

TMUX821x 100V、平坦な Ron、1:1 (SPST)、ラッチアップ耐性、1.8V ロジック対応、4 チャンネル・スイッチ

1 特長

- 広い電源電圧範囲:
 - デュアル電源: $\pm 10V \sim \pm 50V$
 - 単一電源: $10V \sim 100V$
 - 非対称のデュアル電源動作
- 電源電圧範囲全体にわたって安定したパラメータ特性
- ラッチアップ・フリー
- 大きい連続電流: 200mA
- 低いクロストーク: $-110dB$
- 低い入力リーク: 10pA
- 低いオン抵抗平坦性: 0.05 Ω
- 低オン抵抗: 5 Ω
- 低い静電容量: 12pF
- 追加のロジック・レール (V_L) が不要
- 1.8V ロジックに対応
- フェイルセーフ・ロジック: 電源から独立して最大 48V
- ロジック・ピンにプルダウン抵抗を内蔵
- 双方向の信号パス
- 広い動作温度範囲 T_A : $-40^\circ C \sim 125^\circ C$
- 業界標準の TSSOP と
小型の WQFN パッケージ

2 アプリケーション

- 高電圧双方向スイッチング
- アナログおよびデジタル信号スイッチング
- 半導体試験用機器
- LCD 試験装置
- バッテリー試験装置
- データ・アキュイジション・システム (DAQ)
- デジタル・マルチメータ (DMM)
- ファクトリ・オートメーション / 制御
- プログラマブル・ロジック・コントローラ (PLC)
- アナログ入力モジュール

3 概要

TMUX8211、TMUX8212、TMUX8213 は、ラッチアップ・フリーの最新の高電圧対応アナログ・スイッチです。各デバイスは、独立して制御できる 4 つの 1:1 単極単投 (SPST) スwitch・チャンネルを備えています。これらのデバイスは、デュアル電源、単一電源、または最大 100V の非対称電源で正常に動作します。TMUX821x デバイスは、電源電圧範囲全体にわたって安定したアナログ・パラメータ特性を示します。TMUX821x ファミリーは、ソース (S_x) ピンとドレイン (D_x) ピンでの双方向アナログおよびデジタル信号をサポートしています。

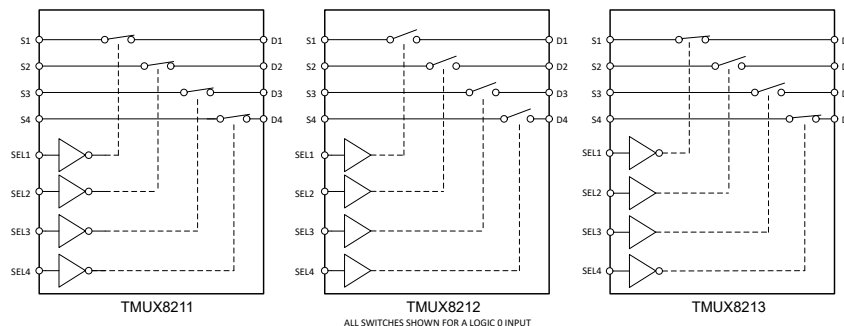
すべてのロジック入力は 1.8V、3.3V、5V のロジック・レベルに対応しており、最高 48V の電圧に接続可能であるため、制御信号電圧について柔軟なシステムを実現します。フェイルセーフ・ロジック回路によって、電源ピンよりも先にロジック・ピンに電圧が印加されるため、デバイスへの損傷の可能性が避けられます。

このデバイス・ファミリーは、ラッチアップ・フリーであるため、デバイス内の寄生構造間の好ましくない大電流イベントを防止できます。ラッチアップ状態は通常、電源レールがオフにされるまで継続するため、デバイスの故障の原因となる場合があります。ラッチアップ・フリーという特長により、このマルチプレクサ・ファミリーは過酷な環境でも使用できます。

パッケージ情報 (1) (2)

部品番号	パッケージ	本体サイズ (公称)
TMUX8211	PW (TSSOP, 16)	5.00mm × 4.40mm
TMUX8212	RUM (WQFN, 16)	4.00mm × 4.00mm
TMUX8213		

- 利用可能なすべてのパッケージについては、このデータシートの末尾にある注文情報を参照してください。
- デバイス比較表を参照してください。



機能ブロック図



Table of Contents

1 特長	1	8.4 Device Turn-On and Turn-Off Time.....	19
2 アプリケーション	1	8.5 Charge Injection.....	20
3 概要	1	8.6 Off Isolation.....	20
4 Revision History	2	8.7 Crosstalk.....	21
5 Device Comparison Table	3	8.8 Bandwidth.....	21
6 Pin Configuration and Functions	3	8.9 THD + Noise.....	22
7 Specifications	4	9 Detailed Description	23
7.1 Absolute Maximum Ratings: TMUX821x Devices.....	4	9.1 Overview.....	23
7.2 ESD Ratings.....	4	9.2 Functional Block Diagram.....	23
7.3 Recommended Operating Conditions:		9.3 Feature Description.....	23
TMUX821x Devices.....	4	9.4 Device Functional Modes.....	25
7.4 ソースまたはドレイン連続電流.....	5	10 Application and Implementation	26
7.5 ドレイン・パルス電流のソース.....	5	10.1 Application Information.....	26
7.6 Thermal Information.....	6	10.2 Typical Application.....	26
7.7 Electrical Characteristics (Global): TMUX821x		11 Power Supply Recommendations	28
Devices.....	6	12 Layout	29
7.8 Electrical Characteristics (±15-V Dual Supply).....	7	12.1 Layout Guidelines.....	29
7.9 Electrical Characteristics (±36-V Dual Supply).....	8	12.2 Layout Example.....	29
7.10 Electrical Characteristics (±50-V Dual Supply).....	9	13 Device and Documentation Support	30
7.11 Electrical Characteristics (72-V Single Supply).....	10	13.1 Documentation Support.....	30
7.12 Electrical Characteristics (100-V Single Supply).....	11	13.2 ドキュメントの更新通知を受け取る方法.....	30
7.13 Switching Characteristics: TMUX821x Devices.....	12	13.3 サポート・リソース.....	30
7.14 Typical Characteristics.....	13	13.4 Trademarks.....	30
8 Parameter Measurement Information	18	13.5 静電気放電に関する注意事項.....	30
8.1 On-Resistance.....	18	13.6 用語集.....	30
8.2 Off-Leakage Current.....	18	14 Mechanical, Packaging, and Orderable	
8.3 On-Leakage Current.....	19	Information	30

4 Revision History

資料番号末尾の英字は改訂を表しています。その改訂履歴は英語版に準じています。

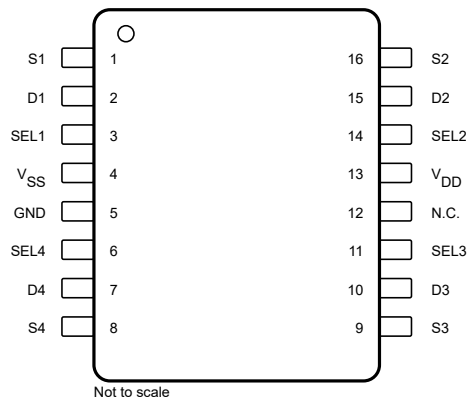
Changes from Revision A (December 2021) to Revision B (March 2023)	Page
• RUM パッケージのステータスをプレビューからアクティブに変更	1

Changes from Revision * (October 2021) to Revision A (December 2021)	Page
• データシートのステータスを「事前情報」から「量産データ」に変更	1

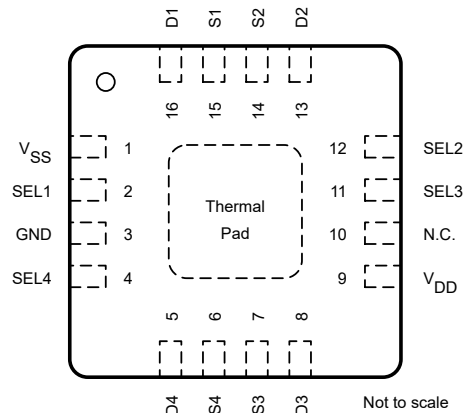
5 Device Comparison Table

PRODUCT	DESCRIPTION
TMUX8211	High Voltage, 4-channel, 1:1 (SPST) switches, (Logic Low)
TMUX8212	High Voltage, 4-channel, 1:1 (SPST) switches, (Logic High)
TMUX8213	High Voltage, 4-channel, 1:1 (SPST) switches, (Logic Low + Logic High)

6 Pin Configuration and Functions



❏ 6-1. PW Package, 16-Pin TSSOP (Top View)



❏ 6-2. RUM Package, 16-Pin WQFN (Top View)

表 6-1. Pin Functions

PIN			TYPE ⁽¹⁾	DESCRIPTION
NAME	TSSOP	WQFN		
D1	2	16	I/O	Drain pin 1. Can be an input or output.
D2	15	13	I/O	Drain pin 2. Can be an input or output.
D3	10	8	I/O	Drain pin 3. Can be an input or output.
D4	7	5	I/O	Drain pin 4. Can be an input or output.
GND	5	3	P	Ground (0 V) reference
S1	1	15	I/O	Source pin 1. Can be an input or output.
S2	16	14	I/O	Source pin 2. Can be an input or output.
S3	9	7	I/O	Source pin 3. Can be an input or output.
S3	9	7	I/O	Source pin 3. Can be an input or output.
S4	8	6	I/O	Source pin 4. Can be an input or output.
SEL1	3	2	I	Logic control input 1.
SEL2	14	12	I	Logic control input 2.
SEL3	11	11	I	Logic control input 3.
SEL4	6	4	I	Logic control input 4.
N.C.	12	10	—	No internal connection.
V _{DD}	13	9	P	Positive power supply. This pin is the most positive power-supply potential. For reliable operation, connect a decoupling capacitor ranging from 1 μ F to 10 μ F between V _{DD} and GND.
V _{SS}	4	1	P	Negative power supply. This pin is the most negative power-supply potential. In single-supply applications, this pin can be connected to ground. For reliable operation, connect a decoupling capacitor ranging from 1 μ F to 10 μ F between V _{SS} and GND.
Thermal Pad			—	The thermal pad is not connected internally. It is recommended that the pad be tied to GND or V _{SS} for best performance.

(1) I = input, O = output, I/O = input and output, P = power

7 Specifications

7.1 Absolute Maximum Ratings: TMUX821x Devices

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

		MIN	MAX	UNIT
$V_{DD}-V_{SS}$	Supply voltage		110	V
V_{DD}		-0.5	110	V
V_{SS}		-110	0.5	V
V_{SELx}	Logic control input pin voltage (SELx)	-0.5	50	V
I_{SELx}	Logic control input pin current (SELx)	-30	30	mA
V_S or V_D	Source or drain voltage (Sx, Dx)	$V_{SS}-2$	$V_{DD}+2$	V
I_{DC}	Source or drain continuous current (Sx, Dx)	-200	200	mA
I_{IK} ⁽²⁾	Diode clamp current at 85°C	-100	100	mA
	Diode clamp current at 125°C	-15	15	mA
T_{stg}	Storage temperature	-65	150	°C
T_A	Ambient temperature	-55	150	°C
T_J	Junction temperature		150	°C
P_{tot} ⁽³⁾	Total power dissipation (QFN)		1680	mW
P_{tot} ⁽⁴⁾	Total power dissipation (TSSOP)		720	mW

- (1) Operation outside the *Absolute Maximum Ratings* may cause permanent device damage. Absolute maximum ratings do not imply functional operation of the device at these or any other conditions beyond those listed under *Recommended Operating Conditions*. If briefly operating outside the *Recommended Operating Conditions* but within the *Absolute Maximum Ratings*, the device may not sustain damage, but it may not be fully functional. Operating the device in this manner may affect device reliability, functionality, performance, and shorten the device lifetime.
- (2) Signal path pins are diode-clamped to the power-supply rails. Over voltage signals must be voltage and current limited to maximum ratings.
- (3) For QFN package: P_{tot} derates linearly above $T_A = 70^\circ\text{C}$ by 24.0 mW/°C
- (4) For TSSOP package: P_{tot} derates linearly above $T_A = 70^\circ\text{C}$ by 10.5 mW/°C

7.2 ESD Ratings

			VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins ⁽¹⁾	±2000	V
		Charged device model (CDM), per ANSI/ESDA/JEDEC JS-002, all pins ⁽²⁾	±500	

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

7.3 Recommended Operating Conditions: TMUX821x Devices

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
$V_{DD} - V_{SS}$ ⁽¹⁾	Power supply voltage differential	10		100	V
V_{DD}	Positive power supply voltage	10		100	V
V_S or V_D ⁽²⁾	Signal path input/output voltage (source or drain pin)	V_{SS}		V_{DD}	V
V_{SEL}	Logic input pin voltage	0		48	V
T_A	Ambient temperature	-40		125	°C
I_S or I_D (CONT)	Source or drain continuous current (Sx, D)			I_{DC} ⁽³⁾	mA

- (1) V_{DD} and V_{SS} can be any value as long as $10\text{ V} \leq (V_{DD} - V_{SS}) \leq 100\text{ V}$, and the minimum V_{DD} is met.
- (2) V_S or V_D is the voltage on any Source or Drain pins.
- (3) Refer to *Source or Drain Continuous Current* table for I_{DC} specifications.

7.4 ソースまたはドレイン連続電流

自由気流での動作温度範囲内 (特に記述のない限り)

	パッケージ			最小値	公称値	最大値	単位
I_{DC} 1 チャンネル ⁽¹⁾	PW (TSSOP) RUM (WQFN)	1 チャンネルのスイッチを流れる連続電流	$T_A = 25^\circ\text{C}$			200	mA
			$T_A = 85^\circ\text{C}$			200	
			$T_A = 125^\circ\text{C}$			200	
I_{DC} すべてのチャンネル ⁽²⁾	PW (TSSOP)	すべてのチャンネルで同時にスイッチを流れる連続電流	$T_A = 25^\circ\text{C}$			185	mA
			$T_A = 85^\circ\text{C}$			125	
			$T_A = 125^\circ\text{C}$			65	
I_{DC} すべてのチャンネル ⁽²⁾	RUM (WQFN)	すべてのチャンネルで同時にスイッチを流れる連続電流	$T_A = 25^\circ\text{C}$			200	mA
			$T_A = 85^\circ\text{C}$			190	
			$T_A = 125^\circ\text{C}$			100	

(1) 一度に 1 つのチャンネルに表示される最大連続電流。

(2) 一度にすべてのチャンネルに表示される最大連続電流。パッケージの制限に違反しないように、最大消費電力 (P_{tot}) を参照してください。

7.5 ドレイン・パルス電流のソース

自由気流での動作温度範囲内 (特に記述のない限り)

	パッケージ			最小値	公称値	最大値	単位
I_{DC} 1 チャンネル ⁽¹⁾	PW (TSSOP)	1 チャンネルのスイッチを流れるパルス ⁽³⁾ 電流	$T_A = 25^\circ\text{C}$			370	mA
			$T_A = 85^\circ\text{C}$			310	
			$T_A = 125^\circ\text{C}$			240	
I_{DC} すべてのチャンネル ⁽²⁾	PW (TSSOP)	すべてのチャンネルで同時にスイッチを流れるパルス ⁽³⁾ 電流	$T_A = 25^\circ\text{C}$			185	mA
			$T_A = 85^\circ\text{C}$			155	
			$T_A = 125^\circ\text{C}$			120	
I_{DC} 1 チャンネル ⁽¹⁾	RUM (WQFN)	1 チャンネルのスイッチを流れるパルス ⁽³⁾ 電流	$T_A = 25^\circ\text{C}$			560	mA
			$T_A = 85^\circ\text{C}$			470	
			$T_A = 125^\circ\text{C}$			365	
I_{DC} すべてのチャンネル ⁽²⁾	RUM (WQFN)	すべてのチャンネルで同時にスイッチを流れるパルス ⁽³⁾ 電流	$T_A = 25^\circ\text{C}$			280	mA
			$T_A = 85^\circ\text{C}$			235	
			$T_A = 125^\circ\text{C}$			180	

(1) 一度に 1 つのチャンネルに表示される最大連続電流。

(2) 一度にすべてのチャンネルに表示される最大連続電流。パッケージの制限に違反しないように、最大消費電力 (P_{tot}) を参照してください。

(3) 1ms でパルス発信、10% のデューティ・サイクル

7.6 Thermal Information

THERMAL METRIC ⁽¹⁾		TMUX821x	TMUX821x	UNIT
		PW (TSSOP)	RUM (WQFN)	
		16 PINS	16 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	96.0	41.6	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	26.8	25.3	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	42.7	16.0	°C/W
Ψ_{JT}	Junction-to-top characterization parameter	1.2	0.3	°C/W
Ψ_{JB}	Junction-to-board characterization parameter	42.0	16.0	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	N/A	3.1	°C/W

(1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

7.7 Electrical Characteristics (Global): TMUX821x Devices

over operating free-air temperature range (unless otherwise noted)

typical at $V_{DD} = +36\text{ V}$, $V_{SS} = -36\text{ V}$, $GND = 0\text{ V}$ and $T_A = 25^\circ\text{C}$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T_A	MIN	TYP	MAX	UNIT
LOGIC INPUTS							
V_{IH}	Logic voltage high		-40°C to $+125^\circ\text{C}$	1.3		48	V
V_{IL}	Logic voltage low		-40°C to $+125^\circ\text{C}$	0		0.8	V
I_{IH}	Input leakage current	Logic inputs = 0 V, 5 V, or 48 V	-40°C to $+125^\circ\text{C}$		0.4	3.8	μA
I_{IL}	Input leakage current	Logic inputs = 0 V, 5 V, or 48 V	-40°C to $+125^\circ\text{C}$	-0.2	-0.005		μA
C_{IN}	Logic input capacitance		-40°C to $+125^\circ\text{C}$		3		pF
POWER SUPPLY							
I_{DD}	V_{DD} supply current	Logic inputs = 0 V, 5 V, or 48 V	25°C		350	800	μA
			-40°C to $+85^\circ\text{C}$			800	μA
			-40°C to $+125^\circ\text{C}$			900	μA
I_{SS}	V_{SS} supply current	Logic inputs = 0 V, 5 V, or 48 V	25°C		350	800	μA
			-40°C to $+85^\circ\text{C}$			800	μA
			-40°C to $+125^\circ\text{C}$			900	μA

7.8 Electrical Characteristics (±15-V Dual Supply)

$V_{DD} = +15\text{ V} \pm 10\%$, $V_{SS} = -15\text{ V} \pm 10\%$, $GND = 0\text{ V}$ (unless otherwise noted)

Typical at $T_A = 25^\circ\text{C}$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T_A	MIN	TYP	MAX	UNIT
ANALOG SWITCH							
R_{ON}	On-resistance	$V_S = -10\text{ V to }+10\text{ V}$ $I_D = -10\text{ mA}$	25°C		5	7	Ω
			$-40^\circ\text{C to }+85^\circ\text{C}$			8	
			$-40^\circ\text{C to }+125^\circ\text{C}$			10	
ΔR_{ON}	On-resistance mismatch between channels	$V_S = -10\text{ V to }+10\text{ V}$ $I_D = -10\text{ mA}$	25°C		0.2	0.3	Ω
			$-40^\circ\text{C to }+85^\circ\text{C}$			0.4	
			$-40^\circ\text{C to }+125^\circ\text{C}$			0.5	
$R_{ON\text{ FLAT}}$	On-resistance flatness	$V_S = -10\text{ V to }+10\text{ V}$ $I_D = -10\text{ mA}$	25°C		0.07		Ω
$R_{ON\text{ DRIFT}}$	On-resistance drift	$V_S = 0\text{ V}$, $I_S = -10\text{ mA}$	$-40^\circ\text{C to }+125^\circ\text{C}$		0.03		$\Omega/^\circ\text{C}$
$I_{S(OFF)}$	Source off leakage current ⁽¹⁾	$V_{DD} = 16.5\text{ V}$, $V_{SS} = -16.5\text{ V}$ Switch state is off $V_S = +10\text{ V} / -10\text{ V}$ $V_D = -10\text{ V} / +10\text{ V}$	25°C		0.01		nA
			$-40^\circ\text{C to }+85^\circ\text{C}$		-4	4	
			$-40^\circ\text{C to }+125^\circ\text{C}$		-40	40	
$I_{D(OFF)}$	Drain off leakage current ⁽¹⁾	$V_{DD} = 16.5\text{ V}$, $V_{SS} = -16.5\text{ V}$ Switch state is off $V_S = +10\text{ V} / -10\text{ V}$ $V_D = -10\text{ V} / +10\text{ V}$	25°C		0.01		nA
			$-40^\circ\text{C to }+85^\circ\text{C}$		-4	4	
			$-40^\circ\text{C to }+125^\circ\text{C}$		-40	40	
$I_{S(ON)}$ $I_{D(ON)}$	Channel on leakage current ⁽²⁾	$V_{DD} = 16.5\text{ V}$, $V_{SS} = -16.5\text{ V}$ Switch state is on $V_S = V_D = \pm 10\text{ V}$	25°C		0.01		nA
			$-40^\circ\text{C to }+85^\circ\text{C}$		-1	1	
			$-40^\circ\text{C to }+125^\circ\text{C}$		-2	2	
$\Delta I_{S(ON)}$ $\Delta I_{D(ON)}$	Leakage current mismatch between channels ⁽²⁾	$V_{DD} = 16.5\text{ V}$, $V_{SS} = -16.5\text{ V}$ Switch state is on $V_S = V_D = \pm 10\text{ V}$	25°C		5		pA
			85°C		35		
			125°C		120		

(1) When V_S is positive, V_D is negative. And when V_S is negative, V_D is positive.

(2) When V_S is at a voltage potential, V_D is floating. And when V_D is at a voltage potential, V_S is floating.

7.9 Electrical Characteristics (±36-V Dual Supply)

$V_{DD} = +36\text{ V} \pm 10\%$, $V_{SS} = -36\text{ V} \pm 10\%$, GND = 0 V (unless otherwise noted)

Typical at $T_A = 25^\circ\text{C}$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T_A	MIN	TYP	MAX	UNIT
ANALOG SWITCH							
R_{ON}	On-resistance	$V_S = -25\text{ V to }+25\text{ V}$ $I_D = -10\text{ mA}$	25°C		5	7	Ω
			–40°C to +85°C			8	
			–40°C to +125°C			10	
ΔR_{ON}	On-resistance mismatch between channels	$V_S = -25\text{ V to }+25\text{ V}$ $I_D = -10\text{ mA}$	25°C		0.1	0.3	Ω
			–40°C to +85°C			0.4	
			–40°C to +125°C			0.5	
$R_{ON\text{ FLAT}}$	On-resistance flatness	$V_S = -25\text{ V to }+25\text{ V}$ $I_D = -10\text{ mA}$	25°C		0.12		Ω
$R_{ON\text{ DRIFT}}$	On-resistance drift	$V_S = 0\text{ V}$, $I_S = -10\text{ mA}$	–40°C to +125°C		0.03		$\Omega/^\circ\text{C}$
$I_{S(OFF)}$	Source off leakage current ⁽¹⁾	$V_{DD} = 39.6\text{ V}$, $V_{SS} = -39.6\text{ V}$ Switch state is off $V_S = +25\text{ V} / -25\text{ V}$ $V_D = -25\text{ V} / +25\text{ V}$	25°C		0.01		nA
			–40°C to +85°C	–4		4	
			–40°C to +125°C	–40		40	
$I_{D(OFF)}$	Drain off leakage current ⁽¹⁾	$V_{DD} = 39.6\text{ V}$, $V_{SS} = -39.6\text{ V}$ Switch state is off $V_S = +25\text{ V} / -25\text{ V}$ $V_D = -25\text{ V} / +25\text{ V}$	25°C		0.01		nA
			–40°C to +85°C	–4		4	
			–40°C to +125°C	–40		40	
$I_{S(ON)}$ $I_{D(ON)}$	Channel on leakage current ⁽²⁾	$V_{DD} = 39.6\text{ V}$, $V_{SS} = -39.6\text{ V}$ Switch state is on $V_S = V_D = \pm 25\text{ V}$	25°C		0.01		nA
			–40°C to +85°C	–1		1	
			–40°C to +125°C	–2		2	
$\Delta I_{S(ON)}$ $\Delta I_{D(ON)}$	Leakage current mismatch between channels ⁽²⁾	$V_{DD} = 39.6\text{ V}$, $V_{SS} = -39.6\text{ V}$ Switch state is on $V_S = V_D = \pm 25\text{ V}$	25°C		5		pA
			85°C		35		
			125°C		120		

(1) When V_S is positive, V_D is negative. And when V_S is negative, V_D is positive.

(2) When V_S is at a voltage potential, V_D is floating. And when V_D is at a voltage potential, V_S is floating.

7.10 Electrical Characteristics (±50-V Dual Supply)

$V_{DD} = +50\text{ V}$, $V_{SS} = -50\text{ V}$, $GND = 0\text{ V}$ (unless otherwise noted)

Typical at $T_A = 25^\circ\text{C}$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T_A	MIN	TYP	MAX	UNIT
ANALOG SWITCH							
R_{ON}	On-resistance	$V_S = -45\text{ V to }45\text{ V}$ $I_D = -10\text{ mA}$	25°C		5	7	Ω
			-40°C to +85°C			8	
			-40°C to +125°C			10	
ΔR_{ON}	On-resistance mismatch between channels	$V_S = -45\text{ V to }45\text{ V}$ $I_D = -10\text{ mA}$	25°C		0.2	0.3	Ω
			-40°C to +85°C			0.4	
			-40°C to +125°C			0.5	
$R_{ON\text{ FLAT}}$	On-resistance flatness	$V_S = -45\text{ V to }45\text{ V}$ $I_D = -10\text{ mA}$	25°C		0.13		Ω
$R_{ON\text{ DRIFT}}$	On-resistance drift	$V_S = 0\text{ V}$, $I_S = -10\text{ mA}$	-40°C to +125°C		0.03		$\Omega/^\circ\text{C}$
$I_{S(OFF)}$	Source off leakage current ⁽¹⁾	$V_{DD} = 50\text{ V}$, $V_{SS} = -50\text{ V}$ Switch state is off $V_S = +45\text{ V} / -45\text{ V}$ $V_D = -45\text{ V} / +45\text{ V}$	25°C		0.01		nA
			-40°C to +85°C	-4		4	
			-40°C to +125°C	-40		40	
$I_{D(OFF)}$	Drain off leakage current ⁽¹⁾	$V_{DD} = 50\text{ V}$, $V_{SS} = -50\text{ V}$ Switch state is off $V_S = +45\text{ V} / -45\text{ V}$ $V_D = -45\text{ V} / +45\text{ V}$	25°C		0.01		nA
			-40°C to +85°C	-4		4	
			-40°C to +125°C	-40		40	
$I_{S(ON)}$ $I_{D(ON)}$	Channel on leakage current ⁽²⁾	$V_{DD} = 50\text{ V}$, $V_{SS} = -50\text{ V}$ Switch state is on $V_S = V_D = \pm 45\text{ V}$	25°C		0.01		nA
			-40°C to +85°C	-2		2	
			-40°C to +125°C	-5		5	
$\Delta I_{S(ON)}$ $\Delta I_{D(ON)}$	Leakage current mismatch between channels ⁽²⁾	$V_{DD} = 50\text{ V}$, $V_{SS} = -50\text{ V}$ Switch state is on $V_S = V_D = \pm 45\text{ V}$	25°C		10		pA
			85°C		50		
			125°C		220		

(1) When V_S is positive, V_D is negative. And when V_S is negative, V_D is positive.

(2) When V_S is at a voltage potential, V_D is floating. And when V_D is at a voltage potential, V_S is floating.

7.11 Electrical Characteristics (72-V Single Supply)

$V_{DD} = +72\text{ V} \pm 10\%$, $V_{SS} = 0\text{ V}$, $GND = 0\text{ V}$ (unless otherwise noted)

Typical at $T_A = 25^\circ\text{C}$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T_A	MIN	TYP	MAX	UNIT
ANALOG SWITCH							
R_{ON}	On-resistance	$V_S = 0\text{ V to }60\text{ V}$ $I_D = -10\text{ mA}$	25°C		5	7	Ω
			$-40^\circ\text{C to }+85^\circ\text{C}$			8	
			$-40^\circ\text{C to }+125^\circ\text{C}$			10	
ΔR_{ON}	On-resistance mismatch between channels	$V_S = 0\text{ V to }60\text{ V}$ $I_D = -10\text{ mA}$	25°C		0.2	0.3	Ω
			$-40^\circ\text{C to }+85^\circ\text{C}$			0.4	
			$-40^\circ\text{C to }+125^\circ\text{C}$			0.5	
$R_{ON\text{ FLAT}}$	On-resistance flatness	$V_S = 0\text{ V to }60\text{ V}$ $I_D = -10\text{ mA}$	25°C		0.05		Ω
$R_{ON\text{ DRIFT}}$	On-resistance drift	$V_S = 0\text{ V}$, $I_S = -10\text{ mA}$	$-40^\circ\text{C to }+125^\circ\text{C}$		0.03		$\Omega/^\circ\text{C}$
$I_{S(OFF)}$	Source off leakage current ⁽¹⁾	Switch state is off $V_S = +60\text{ V} / 1\text{ V}$ $V_D = 1\text{ V} / +60\text{ V}$	25°C		0.01		nA
			$-40^\circ\text{C to }+85^\circ\text{C}$	–4		4	
			$-40^\circ\text{C to }+125^\circ\text{C}$	–40		40	
$I_{D(OFF)}$	Drain off leakage current ⁽¹⁾	Switch state is off $V_S = +60\text{ V} / 1\text{ V}$ $V_D = 1\text{ V} / +60\text{ V}$	25°C		0.01		nA
			$-40^\circ\text{C to }+85^\circ\text{C}$	–4		4	
			$-40^\circ\text{C to }+125^\circ\text{C}$	–40		40	
$I_{S(ON)}$ $I_{D(ON)}$	Channel on leakage current ⁽²⁾	Switch state is on $V_S = V_D = 1\text{ V} / +60\text{ V}$	25°C		0.01		nA
			$-40^\circ\text{C to }+85^\circ\text{C}$	–2		2	
			$-40^\circ\text{C to }+125^\circ\text{C}$	–5		5	
$\Delta I_{S(ON)}$ $\Delta I_{D(ON)}$	Leakage current mismatch between channels ⁽²⁾	Switch state is on $V_S = V_D = 1\text{ V} / +60\text{ V}$	25°C		15		pA
			85°C		75		
			125°C		300		

(1) When V_S is 60 V, V_D is 1 V. Or when V_S is 1 V, V_D is 60 V.

(2) When V_S is at a voltage potential, V_D is floating. Or when V_D is at a voltage potential, V_S is floating.

7.12 Electrical Characteristics (100-V Single Supply)

$V_{DD} = +100\text{ V}$, $V_{SS} = 0\text{ V}$, $GND = 0\text{ V}$ (unless otherwise noted)

Typical at $T_A = 25^\circ\text{C}$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T_A	MIN	TYP	MAX	UNIT
ANALOG SWITCH							
R_{ON}	On-resistance	$V_S = 0\text{ V to }+95\text{ V}$ $I_D = -10\text{ mA}$	25°C		5	7	Ω
			–40°C to +85°C			8	
			–40°C to +125°C			10	
ΔR_{ON}	On-resistance mismatch between channels	$V_S = 0\text{ V to }+95\text{ V}$ $I_D = -10\text{ mA}$	25°C		0.2	0.3	Ω
			–40°C to +85°C			0.4	
			–40°C to +125°C			0.5	
$R_{ON\text{ FLAT}}$	On-resistance flatness	$V_S = 0\text{ V to }+95\text{ V}$ $I_D = -10\text{ mA}$	25°C		0.07		Ω
$R_{ON\text{ DRIFT}}$	On-resistance drift	$V_S = 50\text{ V}$, $I_S = -10\text{ mA}$	–40°C to +125°C		0.03		$\Omega/^\circ\text{C}$
$I_{S(OFF)}$	Source off leakage current ⁽¹⁾	Switch state is off $V_S = +95\text{ V} / 1\text{ V}$ $V_D = 1\text{ V} / +95\text{ V}$	25°C		0.01		nA
			–40°C to +85°C	–4		4	
			–40°C to +125°C	–40		40	
$I_{D(OFF)}$	Drain off leakage current ⁽¹⁾	Switch state is off $V_S = +95\text{ V} / 1\text{ V}$ $V_D = 1\text{ V} / +95\text{ V}$	25°C		0.01		nA
			–40°C to +85°C	–4		4	
			–40°C to +125°C	–40		40	
$I_{S(ON)}$ $I_{D(ON)}$	Channel on leakage current ⁽²⁾	Switch state is on $V_S = V_D = 1\text{ V} / +95\text{ V}$	25°C		0.01		nA
			–40°C to +85°C	–4		4	
			–40°C to +125°C	–10		10	
$\Delta I_{S(ON)}$ $\Delta I_{D(ON)}$	Leakage current mismatch between channels ⁽²⁾	Switch state is on $V_S = V_D = 1\text{ V} / +95\text{ V}$	25°C		15		pA
			85°C		100		
			125°C		450		

(1) When V_S is 95 V, V_D is 1 V. Or when V_S is 1 V, V_D is 95 V.

(2) When V_S is at a voltage potential, V_D is floating. Or when V_D is at a voltage potential, V_S is floating.

7.13 Switching Characteristics: TMUX821x Devices

over operating free-air temperature range (unless otherwise noted)

typical at $V_{DD} = +36\text{ V}$, $V_{SS} = -36\text{ V}$, $GND = 0\text{ V}$ and $T_A = 25^\circ\text{C}$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T_A	MIN	TYP	MAX	UNIT
$t_{ON(EN)}$	Turn-on time from enable	$V_S = 10\text{ V}$ $R_L = 10\text{ k}\Omega$, $C_L = 15\text{ pF}$	25°C		4		μs
			-40°C to $+85^\circ\text{C}$			10	
			-40°C to $+125^\circ\text{C}$			12	
$t_{OFF(EN)}$	Turn-off time from enable	$V_S = 10\text{ V}$ $R_L = 10\text{ k}\Omega$, $C_L = 15\text{ pF}$	25°C		100		ns
			-40°C to $+85^\circ\text{C}$			600	
			-40°C to $+125^\circ\text{C}$			700	
$t_{ON(VDD)}$	Device turn on time (V_{DD} to output)	V_{DD} ramp rate = $1\text{ V}/\mu\text{s}$, $V_S = 10\text{ V}$ $R_L = 10\text{ k}\Omega$, $C_L = 15\text{ pF}$	25°C		60		μs
t_{PD}	Propagation delay	$R_L = 50\text{ }\Omega$, $C_L = 5\text{ pF}$	25°C		190		ps
Q_{INJ}	Charge injection	$V_S = (V_{DD} + V_{SS}) / 2$, $C_L = 1\text{ nF}$	25°C		-1.3		nC
O_{ISO}	Off isolation	$R_L = 50\text{ }\Omega$, $C_L = 5\text{ pF}$ $V_S = (V_{DD} + V_{SS}) / 2$, $f = 100\text{ kHz}$	25°C		-110		dB
X_{TALK}	Inter-channel crosstalk	$R_L = 50\text{ }\Omega$, $C_L = 5\text{ pF}$ $V_S = (V_{DD} + V_{SS}) / 2$, $f = 100\text{ kHz}$	25°C		-110		dB
BW	-3 dB bandwidth	$R_L = 50\text{ }\Omega$, $C_L = 5\text{ pF}$ $V_S = (V_{DD} + V_{SS}) / 2$	25°C		420		MHz
I_L	Insertion loss	$R_L = 50\text{ }\Omega$, $C_L = 5\text{ pF}$ $V_S = (V_{DD} + V_{SS}) / 2$, $f = 1\text{ MHz}$	25°C		-0.4		dB
THD+N	Total harmonic distortion + Noise	Dual supply voltage $V_{PP} = 5\text{ V}$, $V_{BIAS} = (V_{DD} + V_{SS}) / 2$ $R_L = 1\text{ k}\Omega$, $C_L = 5\text{ pF}$, $f = 20\text{ Hz}$ to 20 kHz	25°C		0.0008		%
$C_{S(OFF)}$	Source off capacitance	$V_S = (V_{DD} + V_{SS}) / 2\text{ V}$, $f = 1\text{ MHz}$	25°C		12		pF
$C_{D(OFF)}$	Drain off capacitance	$V_S = (V_{DD} + V_{SS}) / 2\text{ V}$, $f = 1\text{ MHz}$	25°C		12		pF
$C_{S(ON)}$, $C_{D(ON)}$	On capacitance	$V_S = (V_{DD} + V_{SS}) / 2\text{ V}$, $f = 1\text{ MHz}$	25°C		14		pF

7.14 Typical Characteristics

at $T_A = 25^\circ\text{C}$, $V_{DD} = +36\text{ V}$, and $V_{SS} = -36\text{ V}$ (unless otherwise noted)

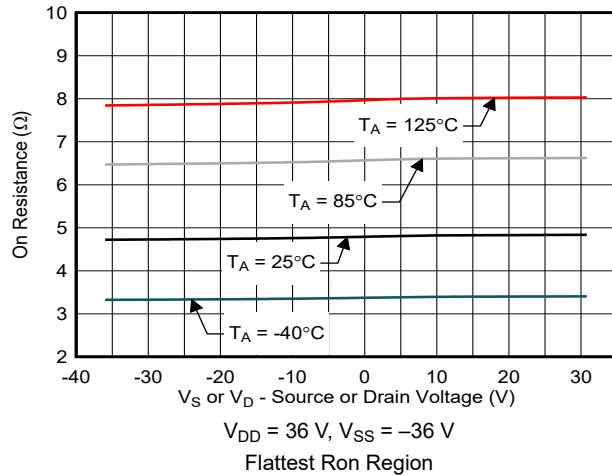


FIG 7-1. On-Resistance vs Source or Drain Voltage

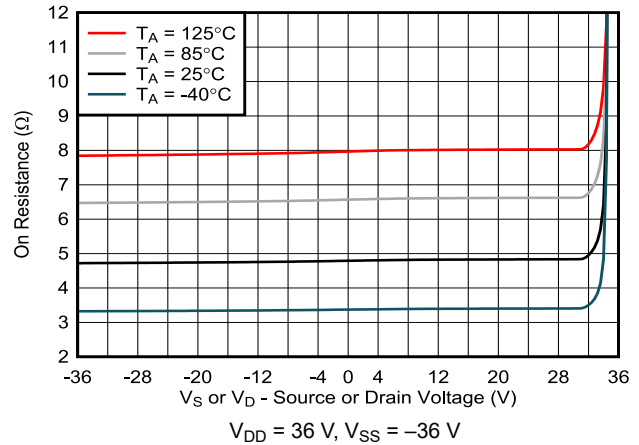


FIG 7-2. On-Resistance vs Source or Drain Voltage

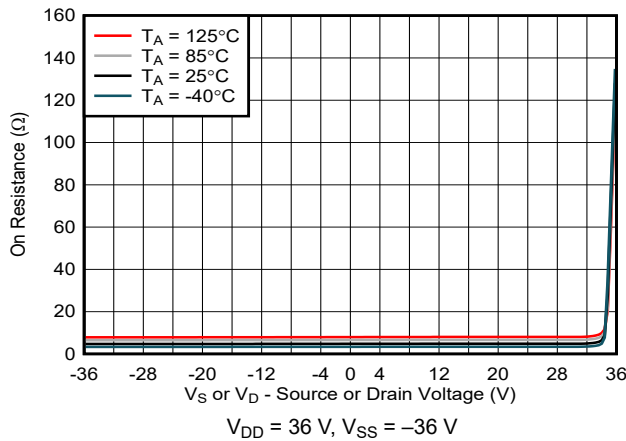


FIG 7-3. On-Resistance vs Source or Drain Voltage

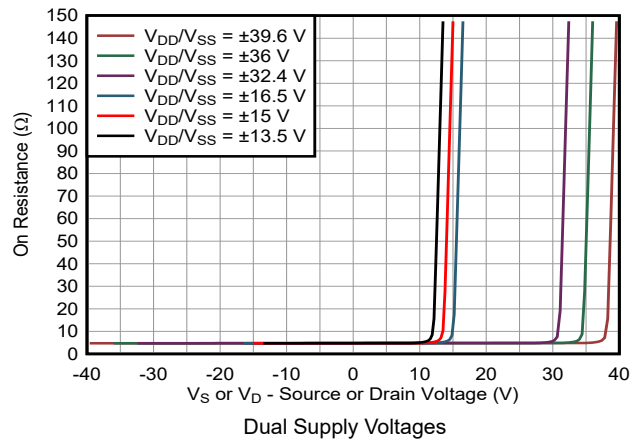


FIG 7-4. On-Resistance vs Source or Drain Voltage

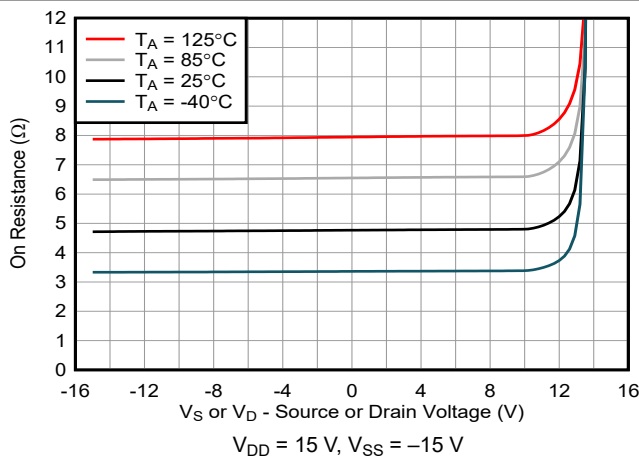


FIG 7-5. On-Resistance vs Source or Drain Voltage

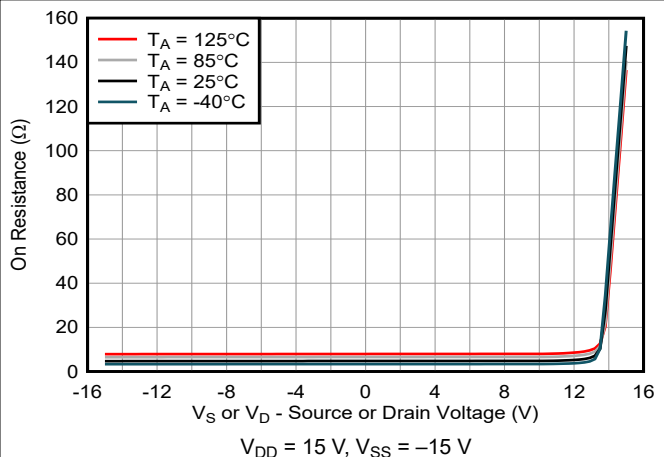


FIG 7-6. On-Resistance vs Source or Drain Voltage

7.14 Typical Characteristics (continued)

at $T_A = 25^\circ\text{C}$, $V_{DD} = +36\text{ V}$, and $V_{SS} = -36\text{ V}$ (unless otherwise noted)

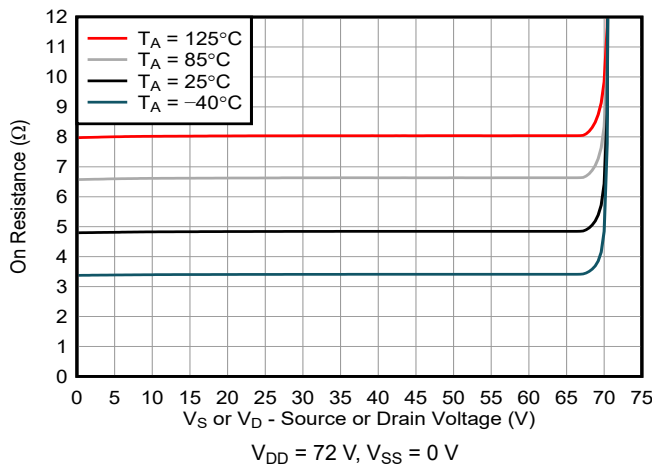


Figure 7-7. On-Resistance vs Source or Drain Voltage

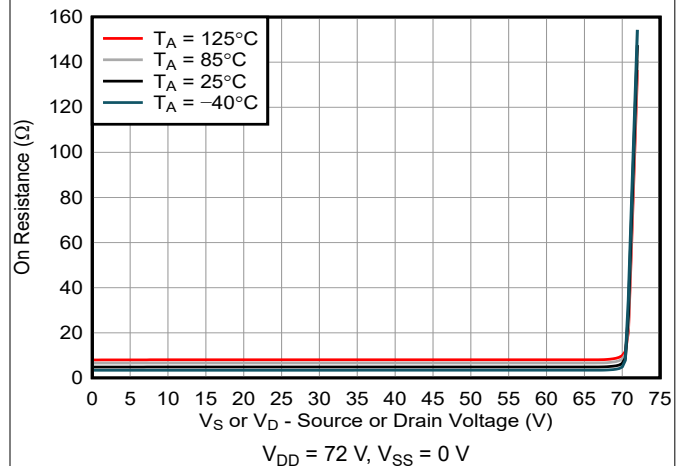


Figure 7-8. On-Resistance vs Source or Drain Voltage

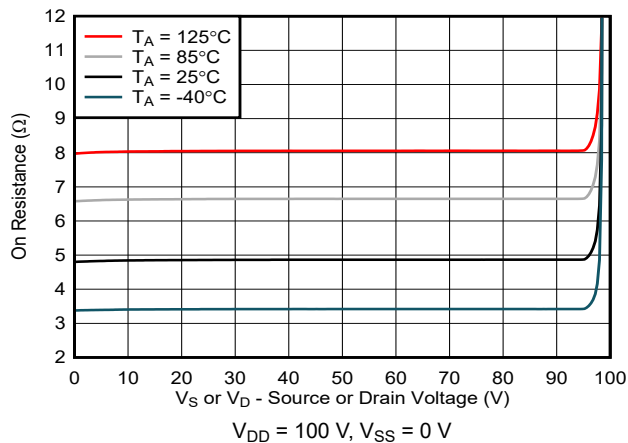


Figure 7-9. On-Resistance vs Source or Drain Voltage

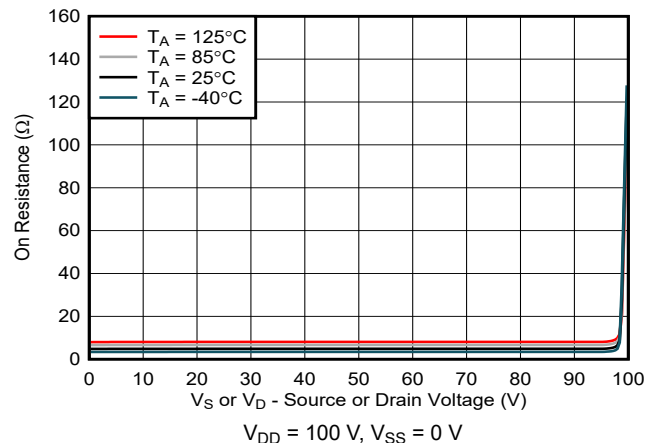


Figure 7-10. On-Resistance vs Source or Drain Voltage

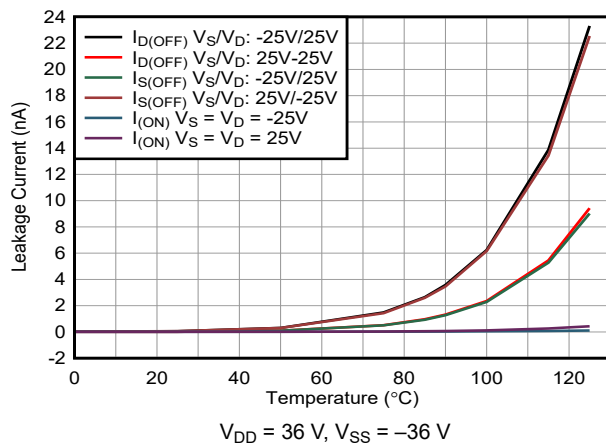


Figure 7-11. Leakage Current vs Temperature

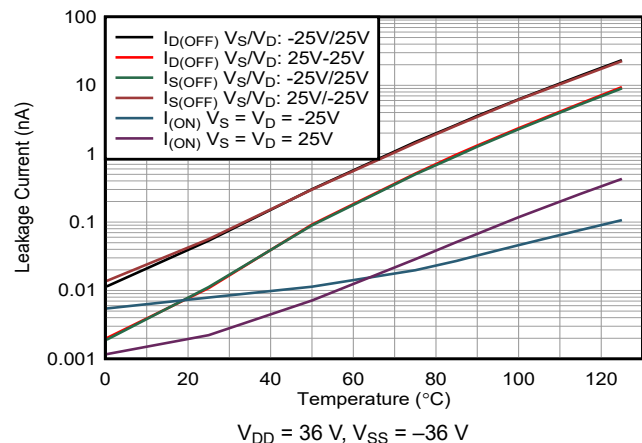
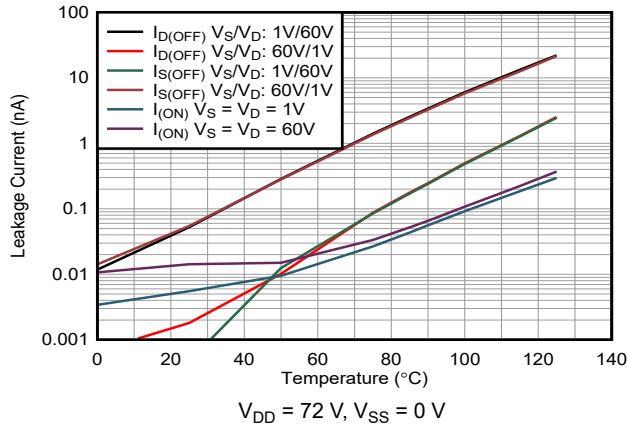


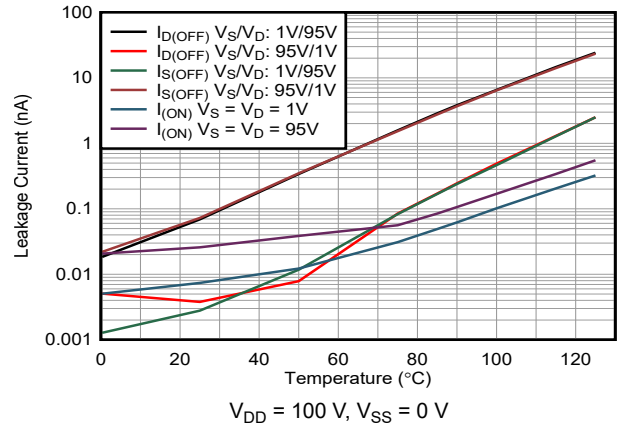
Figure 7-12. Leakage Current vs Temperature

7.14 Typical Characteristics (continued)

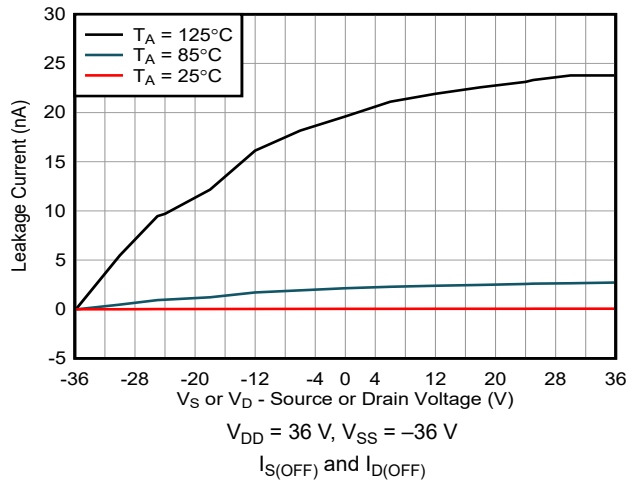
at $T_A = 25^\circ\text{C}$, $V_{DD} = +36\text{ V}$, and $V_{SS} = -36\text{ V}$ (unless otherwise noted)



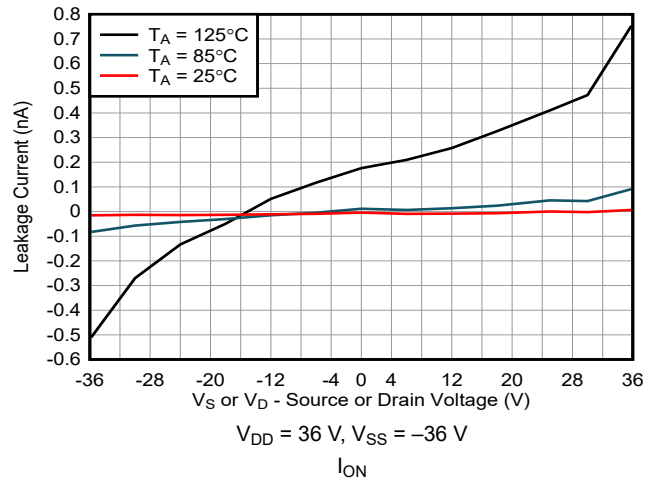
7-13. Leakage Current vs Temperature



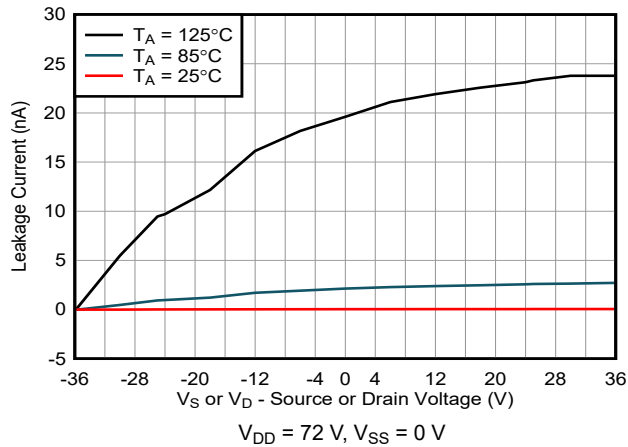
7-14. Leakage Current vs Temperature



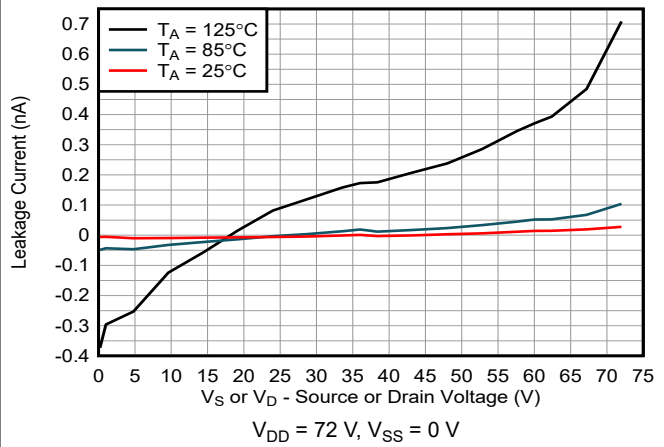
7-15. Off-Leakage Current vs Source or Drain Voltage



7-16. On-Leakage Current vs Source or Drain Voltage



7-17. Off-Leakage Current vs Source or Drain Voltage



7-18. On-Leakage Current vs Source or Drain Voltage

7.14 Typical Characteristics (continued)

at $T_A = 25^\circ\text{C}$, $V_{DD} = +36\text{ V}$, and $V_{SS} = -36\text{ V}$ (unless otherwise noted)

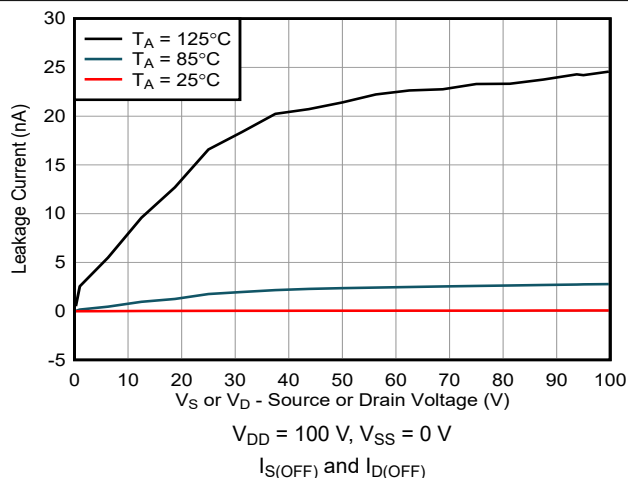


FIG 7-19. Off-Leakage Current vs Source or Drain Voltage

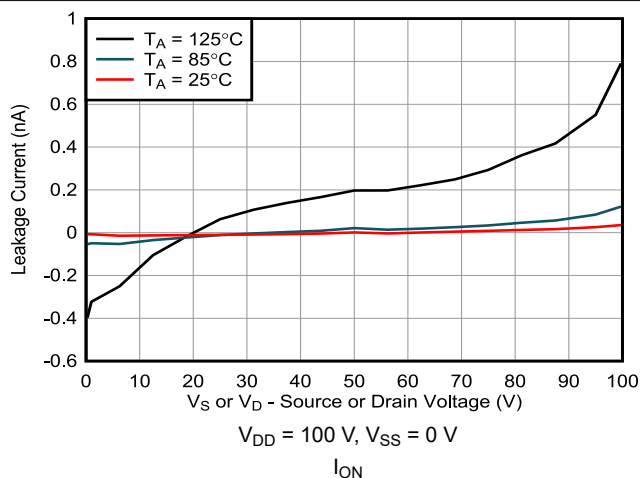


FIG 7-20. On-Leakage Current vs Source or Drain Voltage

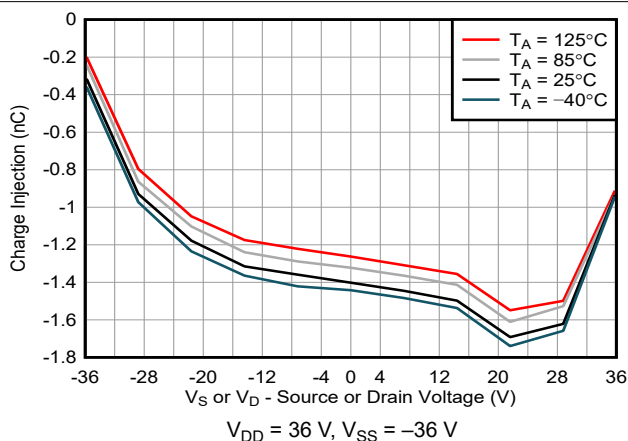


FIG 7-21. Charge Injection vs Source Voltage

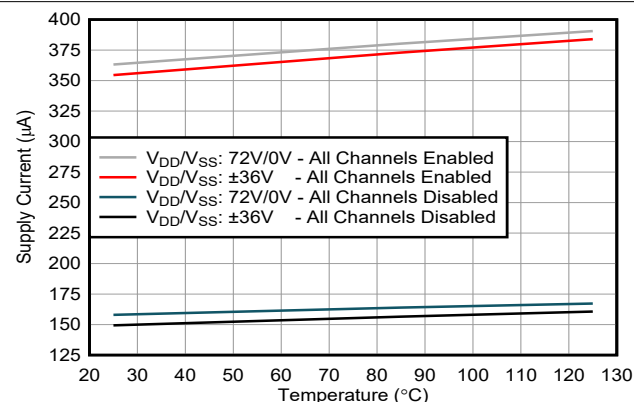


FIG 7-22. Supply Current vs Temperature

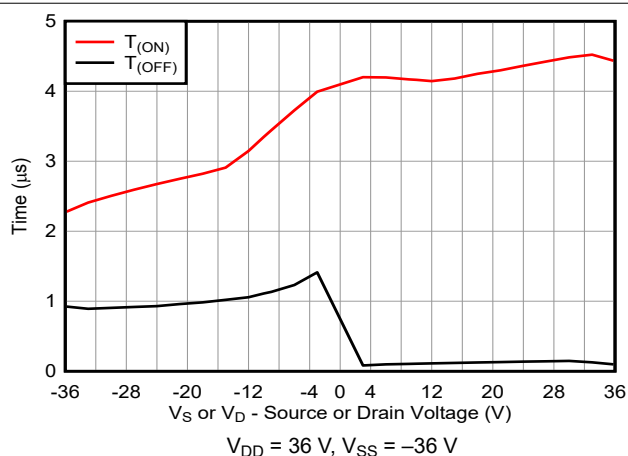


FIG 7-23. Turn-On and Turn-Off Times vs Source Voltage

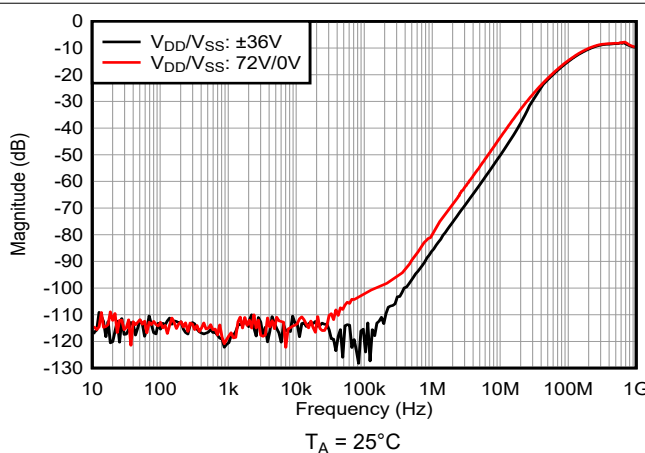
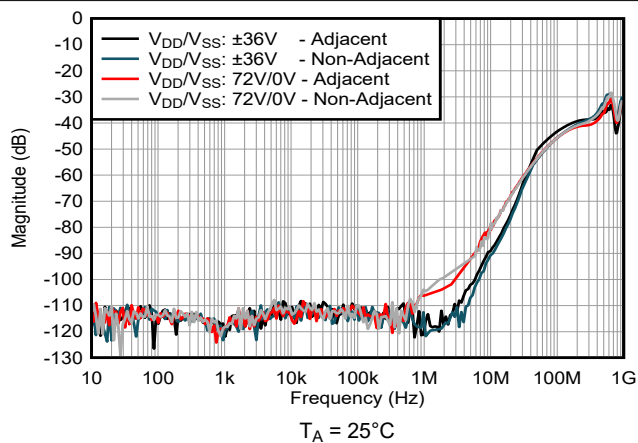


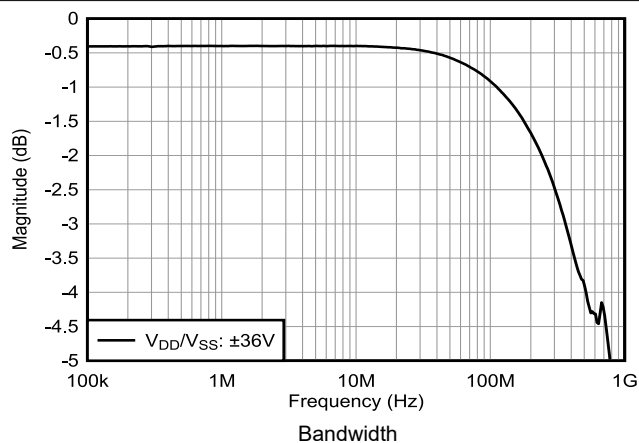
FIG 7-24. Off Isolation vs Frequency

7.14 Typical Characteristics (continued)

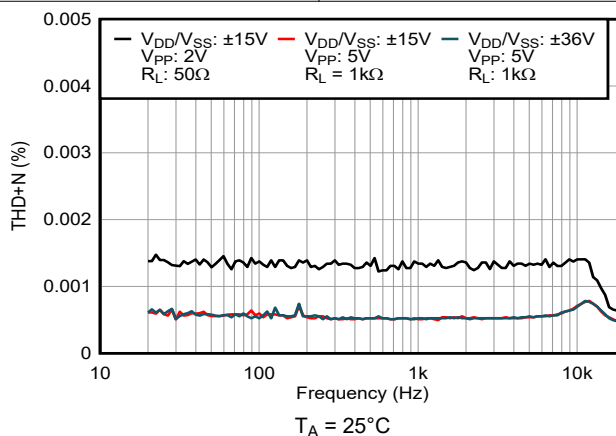
at $T_A = 25^\circ\text{C}$, $V_{DD} = +36\text{ V}$, and $V_{SS} = -36\text{ V}$ (unless otherwise noted)



7-25. Crosstalk vs Frequency



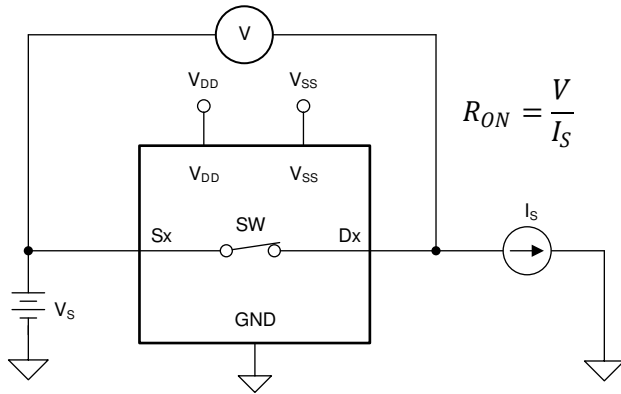
7-26. Insertion Loss vs Frequency

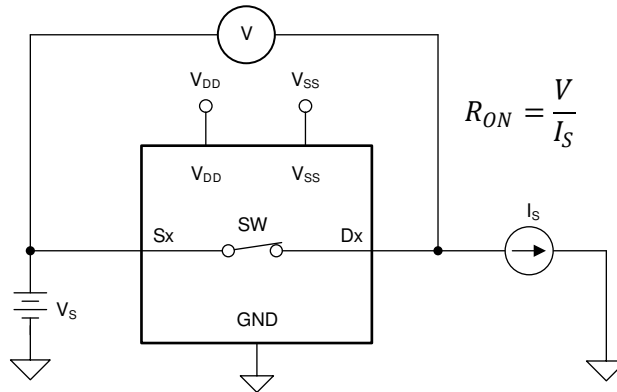


7-27. THD+N vs Frequency

8 Parameter Measurement Information

8.1 On-Resistance

The On-Resistance of the TMUX821x is the ohmic resistance across the source (Sx) and drain (Dx) pins of the device. The On-Resistance varies with input voltage and supply voltage. The symbol R_{ON} is used to denote On-Resistance.  8-1 shows the measurement setup used to measure R_{ON} . ΔR_{ON} represents the difference between the R_{ON} of any two channels, while R_{ON_FLAT} denotes the flatness that is defined as the difference between the maximum and minimum value of On-Resistance measured over the specified analog signal range.

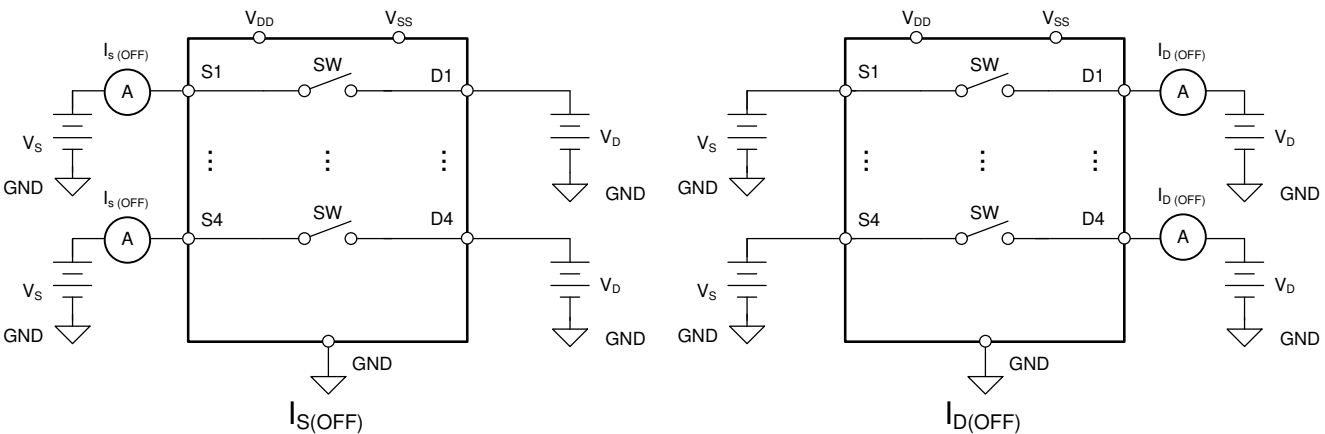


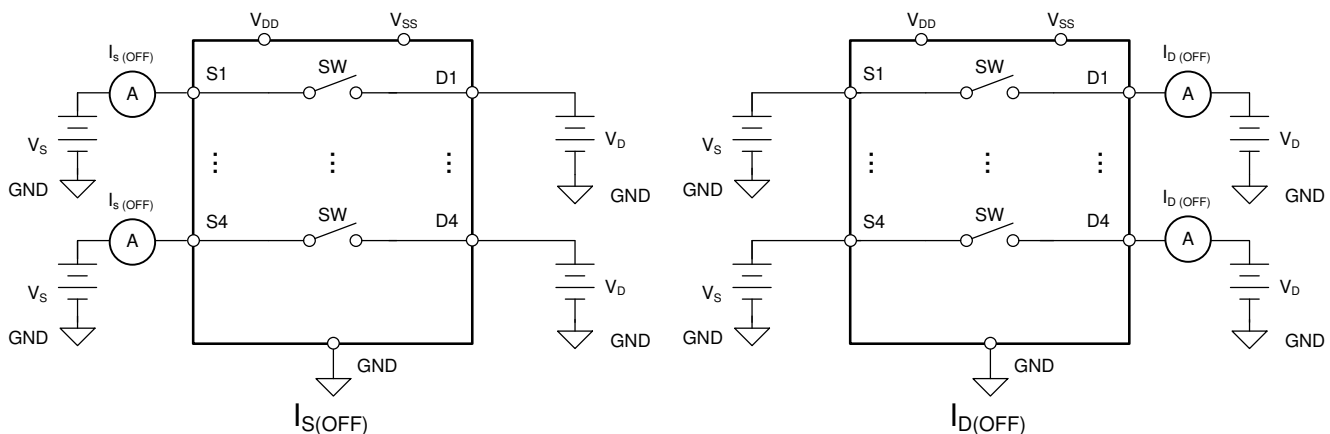
 8-1. On-Resistance Measurement Setup

8.2 Off-Leakage Current

There are two types of leakage currents associated with a switch during the off state:

1. Source Off-Leakage current $I_{S(OFF)}$: the leakage current flowing into or out of the source pin when the switch is off.
2. Drain Off-Leakage current $I_{D(OFF)}$: the leakage current flowing into or out of the drain pin when the switch is off.

 8-2 shows the setup used to measure both Off-Leakage currents.



 8-2. Off-Leakage Measurement Setup

8.3 On-Leakage Current

Source On-Leakage current ($I_{S(ON)}$) and drain On-Leakage current ($I_{D(ON)}$) denote the channel leakage currents when the switch is in the on state. $I_{S(ON)}$ is measured with the drain floating, while $I_{D(ON)}$ is measured with the source floating. Figure 8-3 shows the circuit used for measuring the On-Leakage currents.

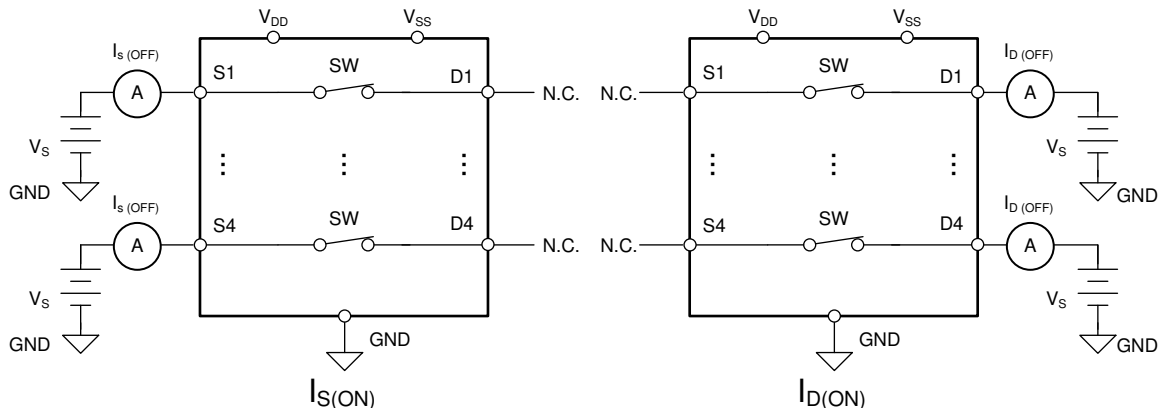


Figure 8-3. On-Leakage Measurement Setup

8.4 Device Turn-On and Turn-Off Time

Turn-On time (t_{ON}) is defined as the time taken by the output of the TMUX8211, TMUX8212, and TMUX8213 to rise to a 90% final value after the SELx signal has risen (for NC switches) or fallen (for NO switches) to a 50% final value. Turn-Off time (t_{OFF}) is defined as the time taken by the output of the TMUX8211, TMUX8212, and TMUX8213 to fall to a 10% initial value after the SELx signal has fallen (for NC switches) or risen (for NO switches) to a 50% initial value. Figure 8-4 shows the setup used to measure t_{ON} and t_{OFF} .

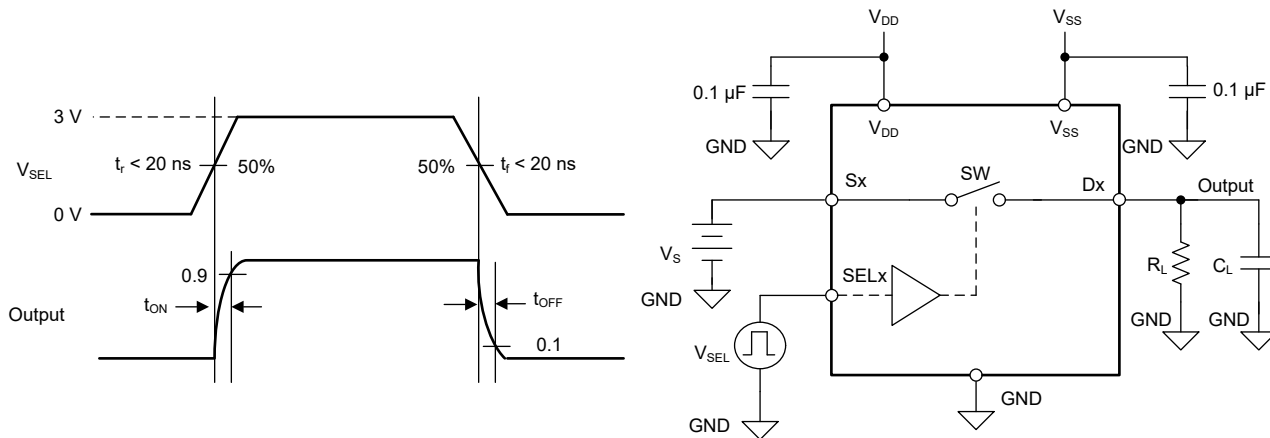


Figure 8-4. Enable Delay Measurement Setup

8.5 Charge Injection

Charge injection is a measure of the glitch impulse transferred from the digital input to the analog output during switching, and is denoted by the symbol Q_{INJ} . Figure 8-5 shows the setup used to measure charge injection from the source to drain.

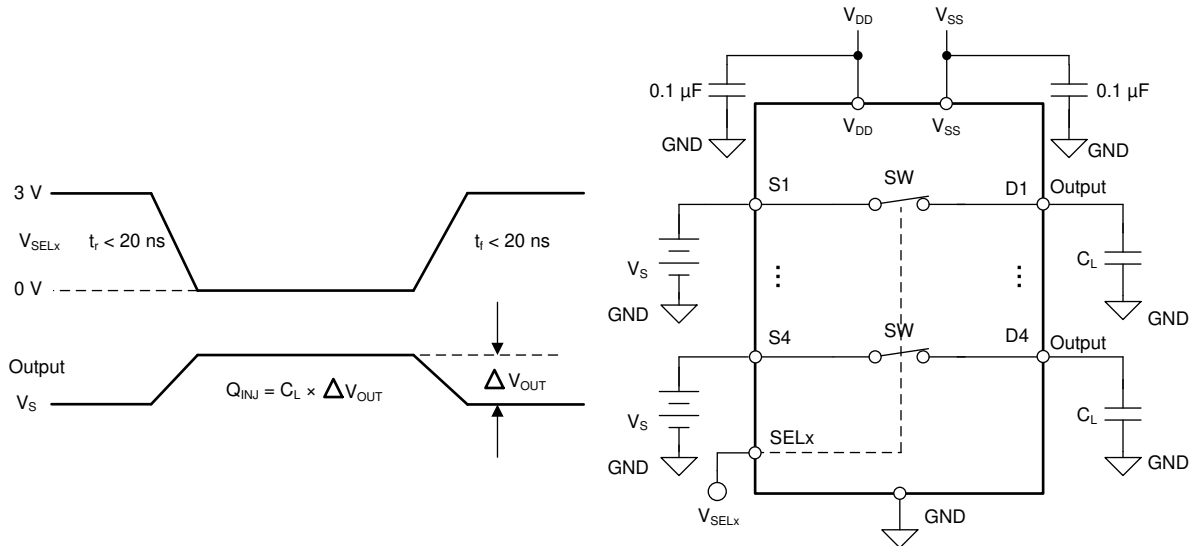


Figure 8-5. Charge-Injection Measurement Setup

8.6 Off Isolation

Off isolation is defined as the ratio of the signal at the drain pin (Dx) of the device when a signal is applied to the source pin (Sx) of an off-channel. The characteristic impedance, Z_O , for the measurement is 50 Ω. Figure 8-6 and Equation 1 shows the setup used to measure off isolation.

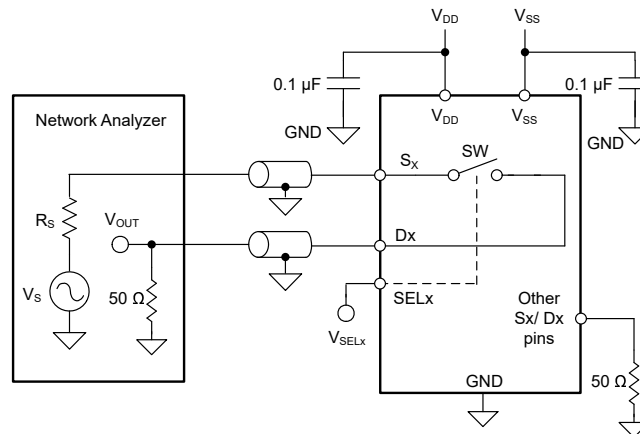


Figure 8-6. Off Isolation Measurement Setup

$$\text{Off Isolation} = 20 \times \log \frac{V_{OUT}}{V_S} \quad (1)$$

8.7 Crosstalk

Crosstalk (X_{TALK}) is defined as the ratio of the signal at the drain pin (D_x) of a different channel, when a signal is applied at the source pin (S_x) of an on-channel. The characteristic impedance, Z_O , for the measurement is 50 Ω , as shown in 図 8-7 and 式 2.

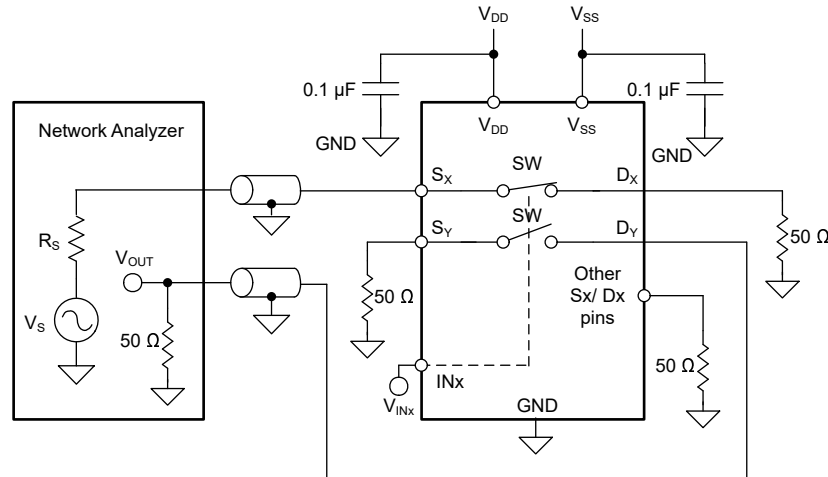


図 8-7. Inter-channel Crosstalk Measurement Setup

$$Inter - channel \text{ Crosstalk} = 20 \times \text{Log} \frac{V_{OUT}}{V_S} \quad (2)$$

8.8 Bandwidth

Bandwidth (BW) is defined as the range of frequencies that are attenuated by < 3 dB when the input is applied to the source pin (S_x) of an on-channel, and the output is measured at the drain pin (D_x). 図 8-8 and 式 3 shows the setup used to measure bandwidth of the switch.

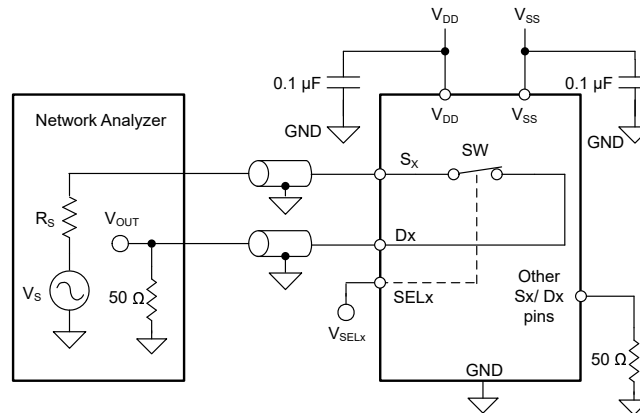


図 8-8. Bandwidth Measurement Setup

$$Bandwidth = 20 \times \text{Log} \frac{V_{OUT}}{V_S} \quad (3)$$

8.9 THD + Noise

The total harmonic distortion (THD) of a signal is a measurement of the harmonic distortion, and is defined as the ratio of the sum of the powers of all harmonic components to the power of the fundamental frequency at the multiplexer output. The On-Resistance of the device varies with the amplitude of the input signal and results in distortion when the drain pin is connected to a low-impedance load. Total harmonic distortion plus noise is denoted as THD+N. [Figure 8-9](#) shows the setup used to measure THD+N of the devices.

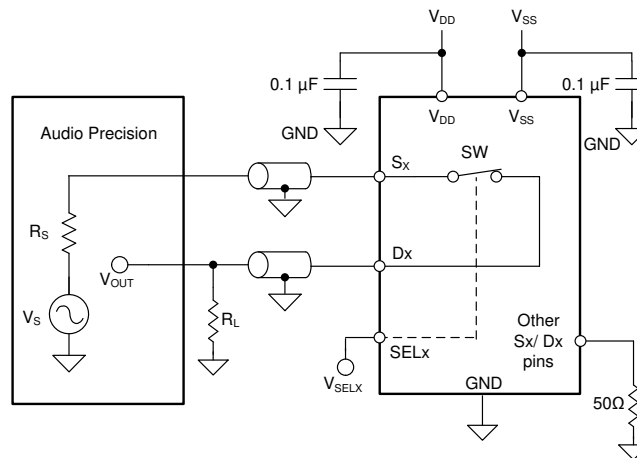


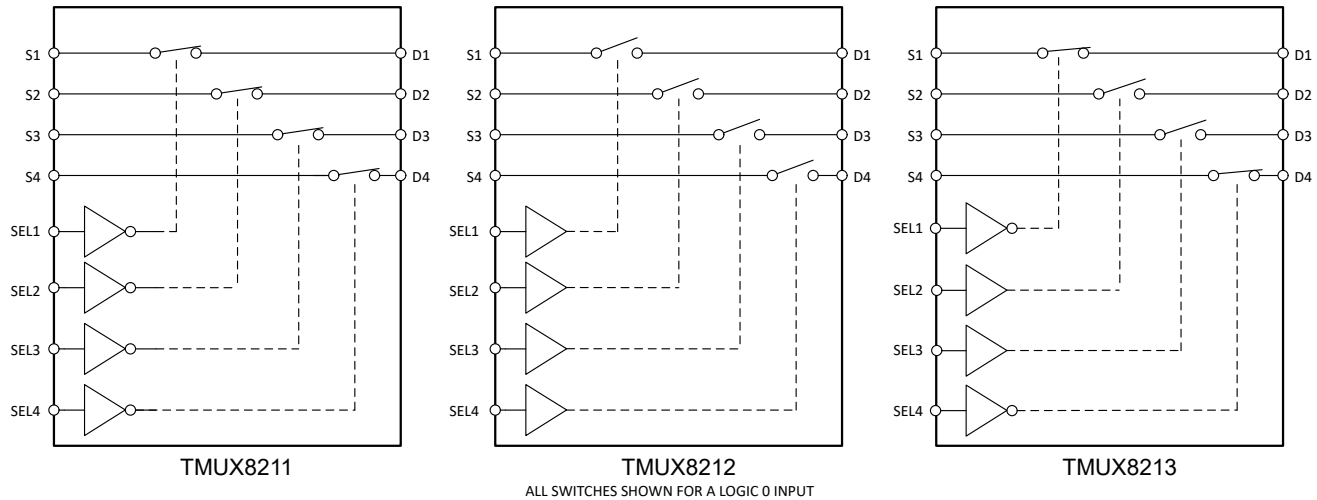
Figure 8-9. THD+N Measurement Setup

9 Detailed Description

9.1 Overview

The TMUX8211, TMUX8212 and TMUX8213 are a modern complementary metal-oxide semiconductor (CMOS) analog switches in quad single-pole single-throw configuration. The devices work well with dual supplies, a single supply, or asymmetric supplies.

9.2 Functional Block Diagram



9.3 Feature Description

9.3.1 Bidirectional Operation

The devices conduct equally well from source (S_x) to drain (D_x) or from drain (D_x) to source (S_x). Each signal path has similar characteristics in both directions.

9.3.2 Flat On-Resistance

The TMUX821x devices are designed with a special switch architecture to produce ultra-flat On-Resistance (R_{ON}) across most of the switch input operating region. The flat R_{ON} response allows the device to be used in precision sensor applications since the R_{ON} is controlled regardless of the signals sampled. The architecture is implemented without a charge pump so no unwanted noise is produced from the device to affect sampling accuracy.

The flattest On-Resistance region extends from V_{SS} to roughly 5 V below V_{DD} . Once the signal is within 5 V of V_{DD} the On-Resistance will exponentially increase and may impact desired signal transmission.

9.3.3 Protection Features

These devices offer a number of protection features to enable robust system implementations.

9.3.3.1 Fail-Safe Logic

Fail-safe logic circuitry allows voltages on the logic control pins to be applied before the supply pins, protecting the device from potential damage. Additionally the fail safe logic feature allows the logic inputs of the mux to be interfaced with high voltages, allowing for simplified interfacing if only high voltage control signals are present. The logic inputs are protected against positive faults of up to +48 V in powered-off condition, but do not offer protection against negative over-voltage condition.

Fail-safe logic also allows the devices to interface with a voltage greater than V_{DD} on the control pins during normal operation to add maximum flexibility in system design. For example, with a $V_{DD} = 15$ V, the logic control pins could be connected to +24 V for a logic high signal which allows different types of signals, such as analog feedback voltages, to be used when controlling the logic inputs. Regardless of the supply voltage, the logic inputs can be interfaced as high as 48 V.

9.3.3.2 ESD Protection

All pins support HBM ESD protection level up to ± 2 kV, which helps protect the devices from ESD events during the manufacturing process.

9.3.3.3 Latch-Up Immunity

Latch-Up is a condition where a low impedance path is created between a supply pin and ground. This condition is caused by a trigger (current injection or over-voltage), but once activated the low impedance path remains even after the trigger is no longer present. This low impedance path may cause system upset or catastrophic damage due to excessive current levels. The Latch-Up condition typically requires a power cycle to eliminate the low impedance path.

In the TMUX821x devices, an insulating oxide layer is placed on top of the silicon substrate to prevent any parasitic junctions from forming. As a result, the devices are Latch-Up immune under all circumstances by device construction.

The TMUX821x devices are constructed on silicon on insulator (SOI) based process where an oxide layer is added between the PMOS and NMOS transistor of each CMOS switch to prevent parasitic structures from forming. The oxide layer is also known as an insulating trench and prevents triggering of latch up events due to over-voltage or current injections. The Latch-Up immunity feature allows the TMUX821x to be used in harsh environments. For more information on Latch-Up immunity, refer to [Using Latch Up Immune Multiplexers to Help Improve System Reliability](#).

9.3.4 1.8 V Logic Compatible Inputs

The TMUX821x devices have 1.8 V logic compatible control for all logic control inputs. 1.8 V logic level inputs allows the TMUX821x to interface with processors that have lower logic I/O rails and eliminates the need for an external translator, which saves both space and BOM cost. For more information on 1.8 V logic implementations, refer to [Simplifying Design with 1.8 V logic Muxes and Switches](#).

9.3.5 Integrated Pull-Down Resistor on Logic Pins

The TMUX821x have internal weak Pull-Down resistors to GND to ensure the logic pins are not left floating. The value of this Pull-Down resistor is approximately 4 M Ω , but is clamped to 1 μ A at higher voltages. This feature integrates up to four external components and reduces system size and cost.

9.4 Device Functional Modes

9.4.1 Normal Mode

In Normal Mode operation, signals of up to V_{DD} and V_{SS} can be passed through the switch from source (Sx) to drain (Dx) or from drain (Dx) to source (Sx). The select (SELx) pins determine which switch path to turn on, according to the [Truth Table](#). The following conditions must be satisfied for the switch to stay in the ON condition:

- The difference between the primary supplies ($V_{DD} - V_{SS}$) must be greater than or equal to 10 V. With a minimum V_{DD} of 10 V.
- The input signals on the source (Sx) or the drain (Dx) must be between V_{DD} and V_{SS} .
- The logic control (SELx) must have selected the switch.

9.4.2 Truth Tables

[表 9-1](#), [表 9-2](#), and [表 9-3](#) show the truth tables for the TMUX8211, TMUX8212, and TMUX8213, respectively.

表 9-1. TMUX8211 Truth Table

SEL # ⁽¹⁾	CHANNEL #
0	Channel # ON
1	Channel # OFF

(1) "#"designates the channel number controlled by SEL pin: "1, 2, 3, or 4"

表 9-2. TMUX8212 Truth Table

SEL # ⁽¹⁾	CHANNEL #
0	Channel # OFF
1	Channel # ON

(1) "#"designates the channel number controlled by SEL pin: "1, 2, 3, or 4"

表 9-3. TMUX8213 Truth Table

SEL1	SEL2	SEL3	SEL4	ON / OFF CHANNELS
0	X ⁽¹⁾	X	X	CHANNEL 1 ON
1	X	X	X	CHANNEL 1 OFF
X	0	X	X	CHANNEL 2 OFF
X	1	X	X	CHANNEL 2 ON
X	X	0	X	CHANNEL 3 OFF
X	X	1	X	CHANNEL 3 ON
X	X	X	0	CHANNEL 4 ON
X	X	X	1	CHANNEL 4 OFF

(1) "X" means "do not care."

If unused, then the SELx pins must be tied to GND or Logic High so that the devices do not consume additional current as highlighted in [Implications of Slow or Floating CMOS Inputs](#). Unused signal path inputs (Sx or Dx) should be connected to GND for best performance.

10 Application and Implementation

注

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10.1 Application Information

The TMUX821x are high voltage switches capable of supporting analog and digital signals. The high voltage capability of these multiplexers allow them to be used in systems with high voltage signal swings, or in systems with high common mode voltages.

Additionally, the TMUX821x devices provide consistent analog parametric performance across the entire supply voltage range allowing the devices to be powered by the most convenient supply rails in the system while still providing excellent performance.

10.2 Typical Application

A common feature of many PMUs (precision measurement units) is the ability to change current ranges. This allows for a system defined current clamp when testing devices and reduces possible damage to the PMU and DUT (device under test). In high voltage PMUs, large relays are often used to enable this switching, but this comes with the trade-off of size. To reduce system size, a multi-channel high voltage switch can be added to facilitate this switching with minimal impact to system size and performance. The TMUX821x allows for switching between multiple current ranges, and has the added flexibility to use multiple channels in parallel for high current applications.

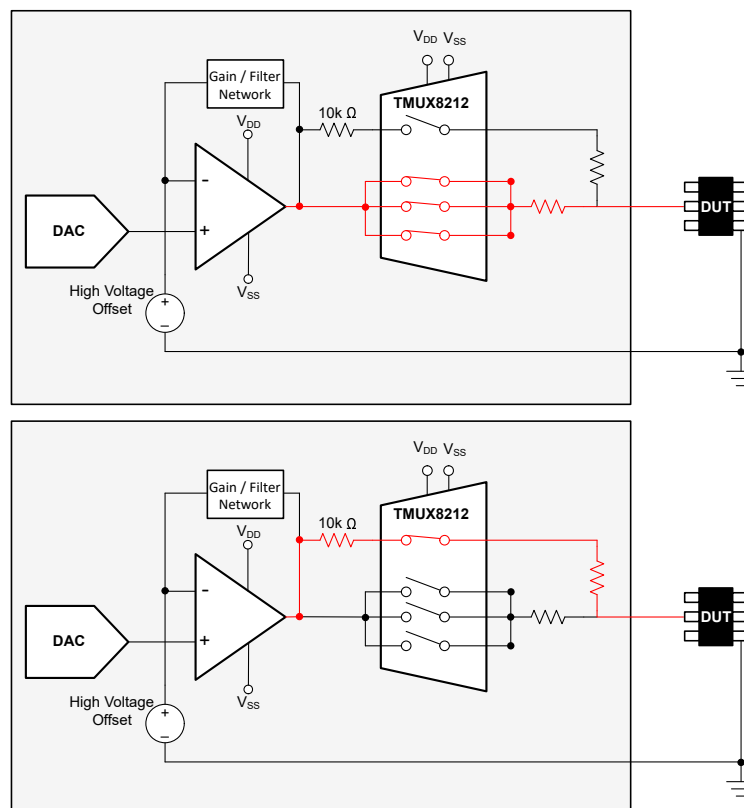


FIG 10-1. TMUX8212 Application Schematic

10.2.1 Design Requirements

表 10-1. Design Parameters

PARAMETERS	VALUES
Positive supply (V_{DD}) mux and Op Amps	36 V
Positive supply (V_{SS}) mux and Op Amps	-36 V
Maximum input or output signals with common mode shift	-36 V to 36 V
Control logic thresholds	1.8 V compatible, up to 48 V
Temperature range	-40°C to +125°C

10.2.2 Detailed Design Procedure

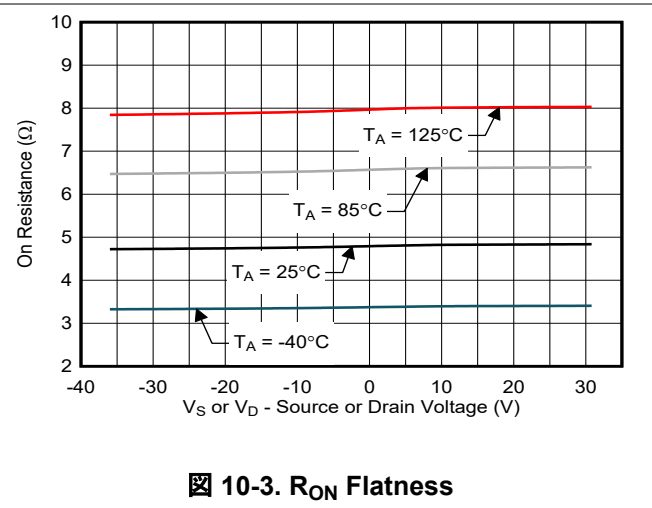
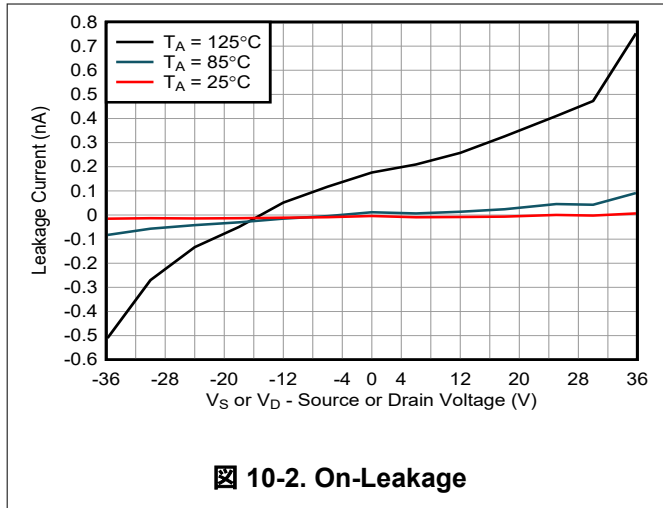
Multiplexing PMU systems enables a small, flexible solution that can be used over a wide range of current ranges. TI's high voltage multiplexers offer a size advantage over typical relay solutions while still achieving an extremely low level of distortion, noise, and leakage. This high voltage multiplexer can be use in tandem with high voltage operational amplifiers and DACs to create an accurate PMU with excellent signal-to-noise ratio.

In this example application, the TMUX8212 is paired with a high voltage amplifier and a DAC. The DAC generates an arbitrary voltage signal that feeds into the amplifier. An additional high voltage offset is also fed into the amplifier to add any needed common mode shift. This arbitrary signal is then passed through a current limiting resistor before reaching the DUT. To change the current range of the system, different current limiting resistors are added in series with each channel of the multiplexer. In this example, the first channel of the multiplexer uses a 10 kΩ resistor for the low current clamp. The maximum output current of the PMU in this range is 5 mA because of this design. During the system operation, the PMU is set to this lower current range in the beginning of the test routine. After the DUT is initially checked in this range and is operating normally with no unexpected shorts, the current range can be switched to high current. This way the PMU and DUT will not be unnecessarily damaged from excess current due to a short. In this example, the remaining three channels of the TMUX8212 are connected in parallel, increasing the maximum current through the device and reducing the low On-Resistance. Because of the flexibility of the TMUX8212, this could easily be modified to fit any system need. For example, if less maximum current is needed, then two channels could be connected in parallel instead of three, and the additional single channel could be used to add a third current range option. The additional input channels make this multiplexed application increasingly valuable by greatly reducing solution size.

The TMUX821x switches have exceptionally flat On-Resistance and low leakage currents across the signal voltage range. The ultra-flat On-Resistance keeps the current clamp constant across the signal voltage range, and the low leakage current reduces the potential noise/offset when measuring on the lowest current range. Additionally, excellent crosstalk and off-isolation performance allows the TMUX821x devices to perform well in multi-channel switching applications without having an unselected channel impact the measurement on selected channels.

10.2.3 Application Curves

The example application utilizes the excellent leakage and On-Resistance flatness performance of the TMUX821x devices. [Figure 10-2](#) shows the leakage current for a channel that is ON across a varying source voltage. [Figure 10-3](#) shows the extremely flat On-Resistance across source voltage while operating within the flattest R_{ON} range of the TMUX821x devices. These features make the devices an ideal solution for applications that require excellent linearity and low distortion.



11 Power Supply Recommendations

The TMUX821x devices operate across a wide supply range of ± 10 V to ± 50 V (10 V to 100 V in single-supply mode). They also perform well with asymmetrical supplies such as $V_{DD} = 50$ V and $V_{SS} = -10$ V. For improved supply noise immunity, use a supply decoupling capacitor ranging from 1 μ F to 10 μ F at both the V_{DD} and V_{SS} pins to ground. An additional 0.1 μ F capacitor placed closest to the supply pins will provide the best supply decoupling solution. Always ensure the ground (GND) connection is established before supplies are ramped.

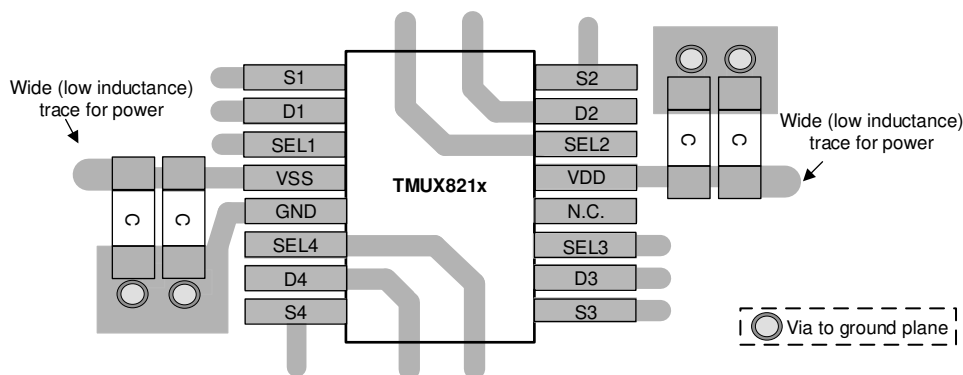
12 Layout

12.1 Layout Guidelines

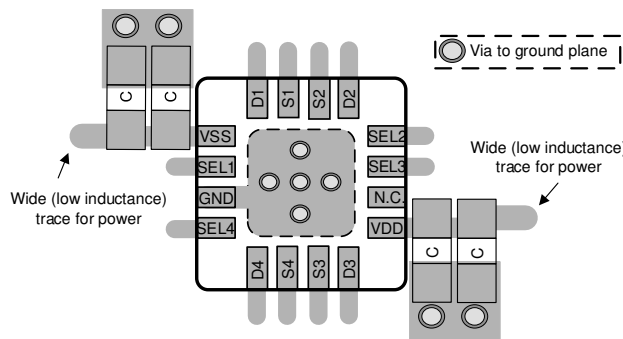
The image below illustrates an example of a PCB layout with the TMUX821x device. Some key considerations are:

- For reliable operation, connect at least one decoupling capacitor ranging from 0.1 μF to 10 μF between V_{DD} and V_{SS} to GND. We recommend a 0.1 μF and 1 μF capacitor, placing the lowest value capacitor as close to the pin as possible. Make sure that the capacitor voltage rating is sufficient for the supply voltage.
- Keep the input lines as short as possible.
- Use a solid ground plane to help distribute heat and reduce electromagnetic interference (EMI) noise pickup.
- Do not run sensitive analog traces in parallel with digital traces. Avoid crossing digital and analog traces if possible, and only make perpendicular crossings when necessary.

12.2 Layout Example



❏ 12-1. TMUX821x TSSOP Layout Example



❏ 12-2. TMUX821x QFN Layout Example

13 Device and Documentation Support

13.1 Documentation Support

13.1.1 Related Documentation

For related documentation, see the following:

- Texas Instruments, [Implications of Slow or Floating CMOS Inputs application note](#)
- Texas Instruments, [Multiplexers and Signal Switches Glossary application report](#)
- Texas Instruments, [Using Latch-Up Immune Multiplexers to Help Improve System Reliability application report](#)

13.2 ドキュメントの更新通知を受け取る方法

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13.6 用語集

[テキサス・インスツルメンツ用語集](#) この用語集には、用語や略語の一覧および定義が記載されています。

14 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
TMUX8211PWR	Active	Production	TSSOP (PW) 16	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	TM8211
TMUX8211PWR.B	Active	Production	TSSOP (PW) 16	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	TM8211
TMUX8211RUMR	Active	Production	WQFN (RUM) 16	3000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	TMUX 8211
TMUX8211RUMR.B	Active	Production	WQFN (RUM) 16	3000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	TMUX 8211
TMUX8212PWR	Active	Production	TSSOP (PW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	TM8212
TMUX8212PWR.B	Active	Production	TSSOP (PW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	TM8212
TMUX8212PWRG4	Active	Production	TSSOP (PW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	TM8212
TMUX8212PWRG4.B	Active	Production	TSSOP (PW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	TM8212
TMUX8212RUMR	Active	Production	WQFN (RUM) 16	3000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	TMUX 8212
TMUX8212RUMR.B	Active	Production	WQFN (RUM) 16	3000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	TMUX 8212
TMUX8213PWR	Active	Production	TSSOP (PW) 16	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	TM8213
TMUX8213PWR.B	Active	Production	TSSOP (PW) 16	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	TM8213
TMUX8213RUMR	Active	Production	WQFN (RUM) 16	3000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	TMUX 8213
TMUX8213RUMR.B	Active	Production	WQFN (RUM) 16	3000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	TMUX 8213

⁽¹⁾ **Status:** For more details on status, see our [product life cycle](#).

⁽²⁾ **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

⁽⁴⁾ **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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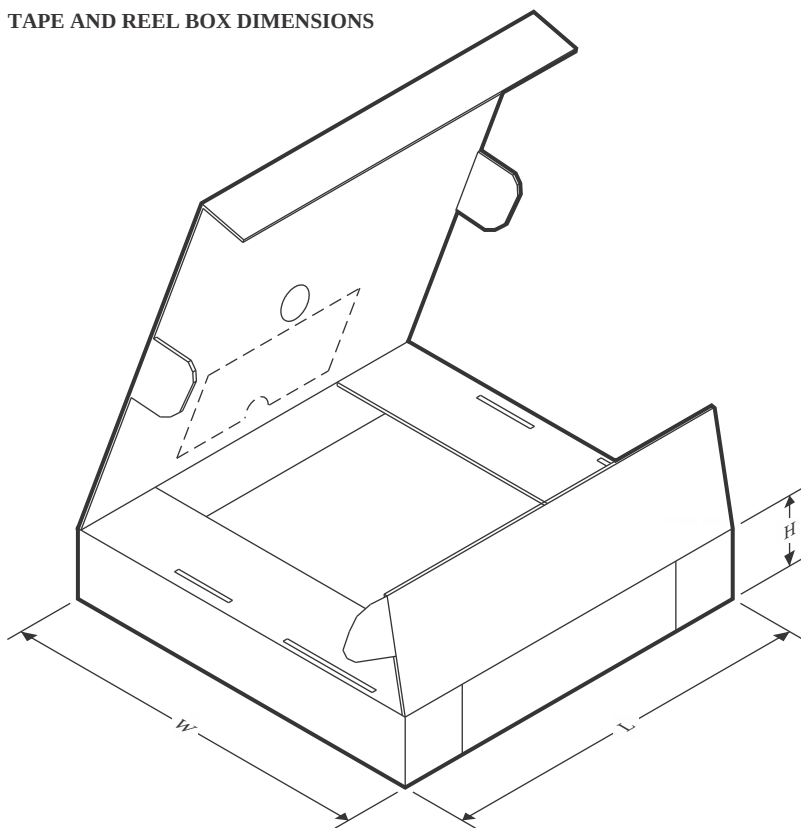
TAPE AND REEL INFORMATION



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TMUX8211PWR	TSSOP	PW	16	3000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
TMUX8211RUMR	WQFN	RUM	16	3000	330.0	12.4	4.25	4.25	1.15	8.0	12.0	Q2
TMUX8212PWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
TMUX8212PWRG4	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
TMUX8212RUMR	WQFN	RUM	16	3000	330.0	12.4	4.25	4.25	1.15	8.0	12.0	Q2
TMUX8213PWR	TSSOP	PW	16	3000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
TMUX8213RUMR	WQFN	RUM	16	3000	330.0	12.4	4.25	4.25	1.15	8.0	12.0	Q2

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TMUX8211PWR	TSSOP	PW	16	3000	353.0	353.0	32.0
TMUX8211RUMR	WQFN	RUM	16	3000	360.0	360.0	36.0
TMUX8212PWR	TSSOP	PW	16	2000	353.0	353.0	32.0
TMUX8212PWRG4	TSSOP	PW	16	2000	353.0	353.0	32.0
TMUX8212RUMR	WQFN	RUM	16	3000	360.0	360.0	36.0
TMUX8213PWR	TSSOP	PW	16	3000	353.0	353.0	32.0
TMUX8213RUMR	WQFN	RUM	16	3000	360.0	360.0	36.0

GENERIC PACKAGE VIEW

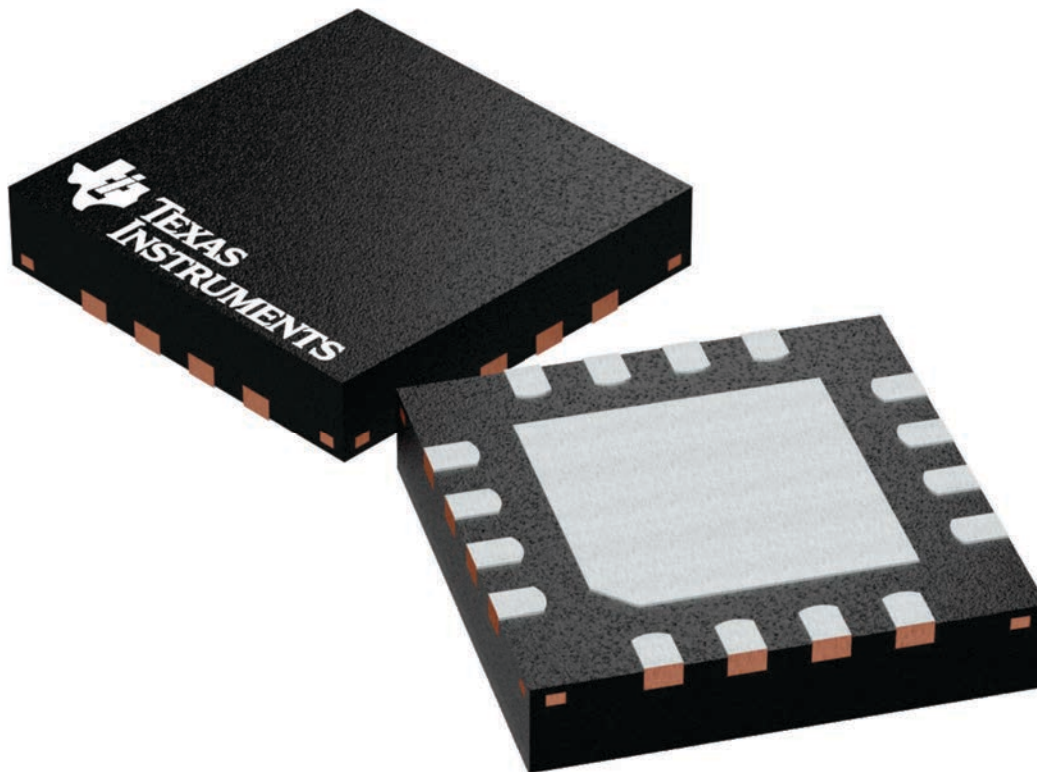
RUM 16

WQFN - 0.8 mm max height

4 x 4, 0.65 mm pitch

PLASTIC QUAD FLATPACK - NO LEAD

This image is a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.



4224843/A

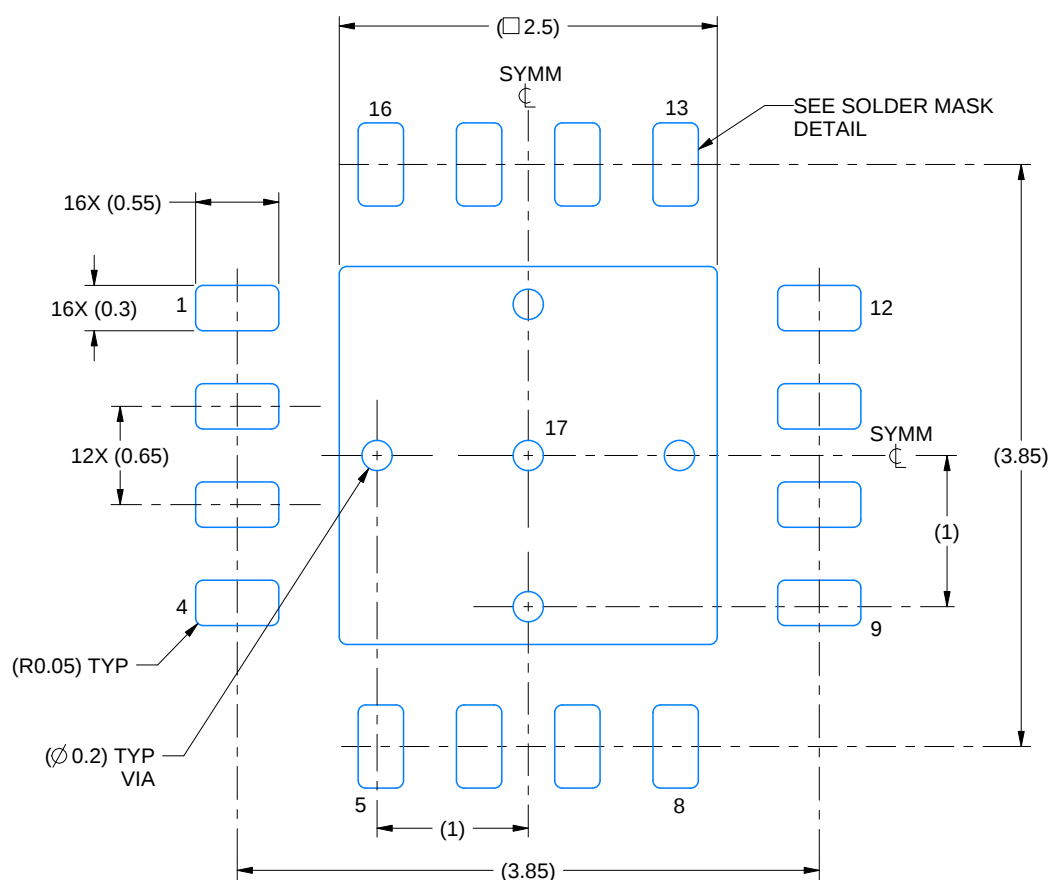


1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

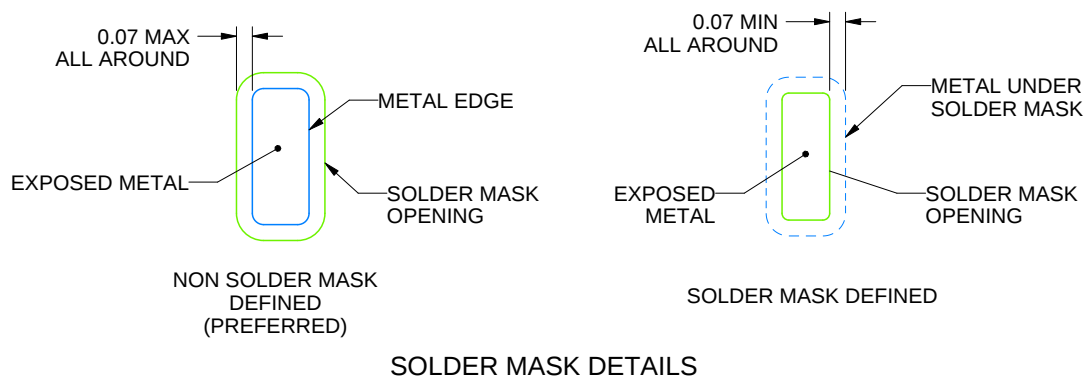
RUM0016E

WQFN - 0.8 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 20X



4224815/B 03/2026

NOTES: (continued)

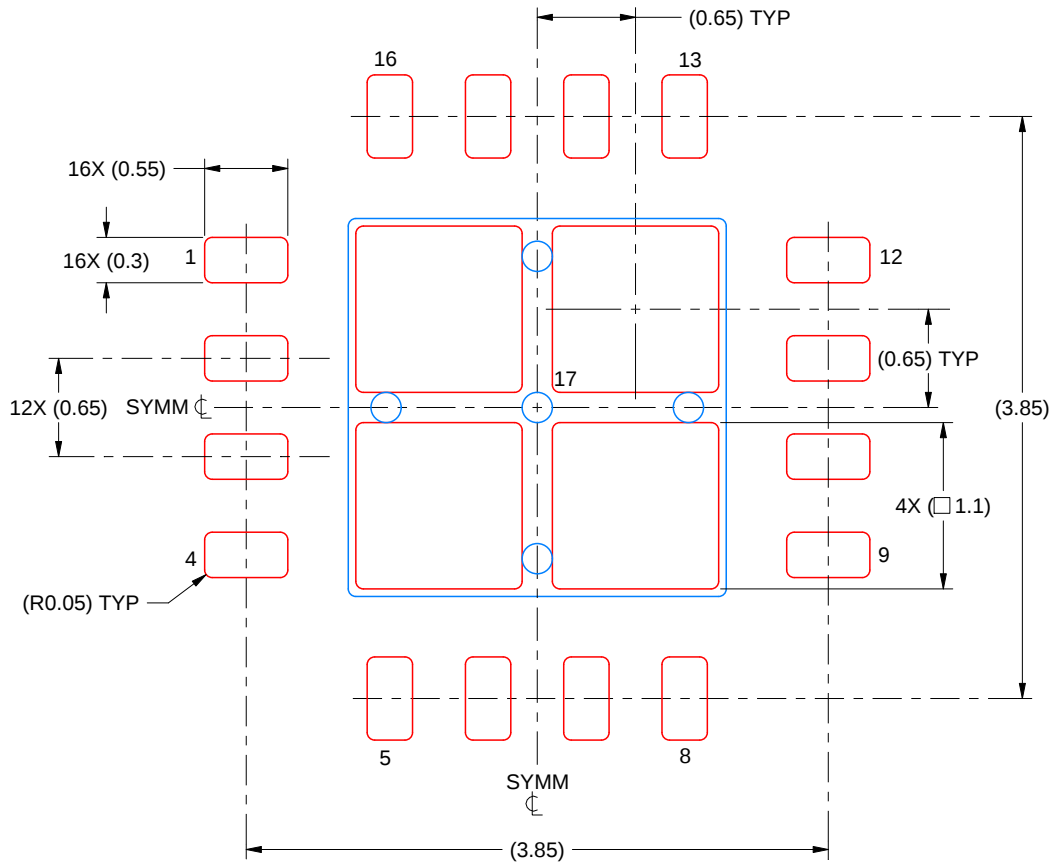
4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.

EXAMPLE STENCIL DESIGN

RUM0016E

WQFN - 0.8 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



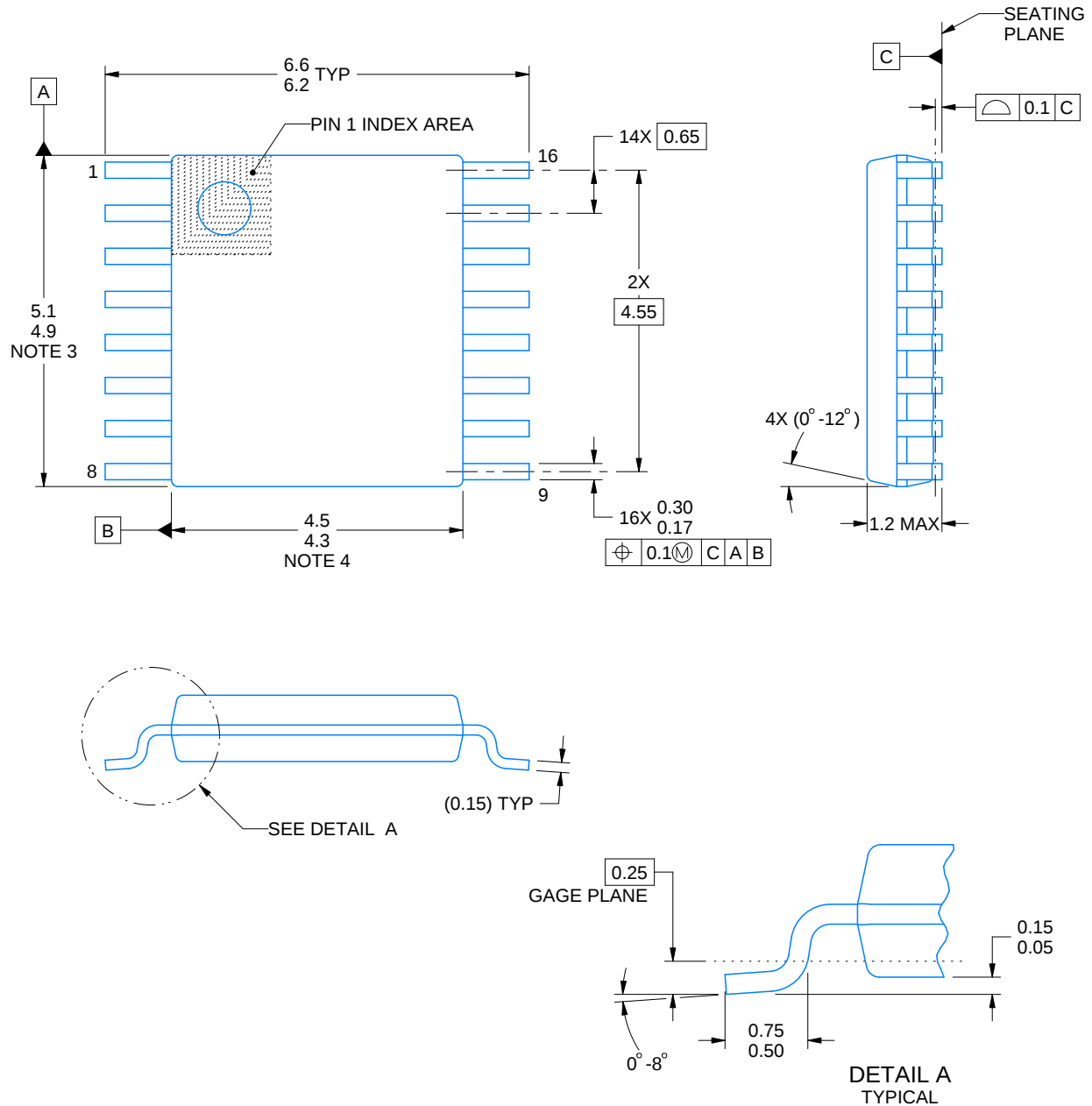
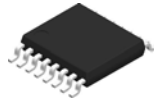
SOLDER PASTE EXAMPLE
BASED ON 0.125 MM THICK STENCIL
SCALE: 20X

EXPOSED PAD 17
77% PRINTED SOLDER COVERAGE BY AREA UNDER PACKAGE

4224815/B 03/2026

NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



4220204/B 12/2023

NOTES:

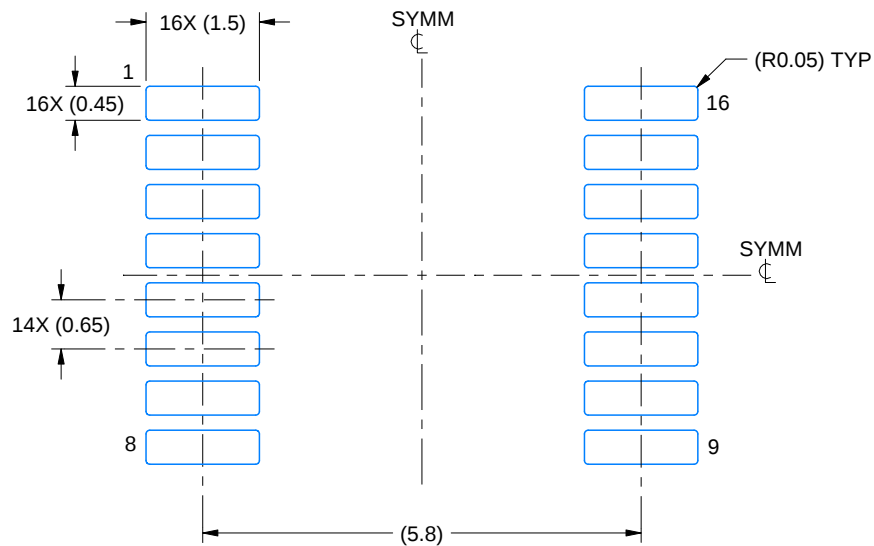
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-153.

EXAMPLE BOARD LAYOUT

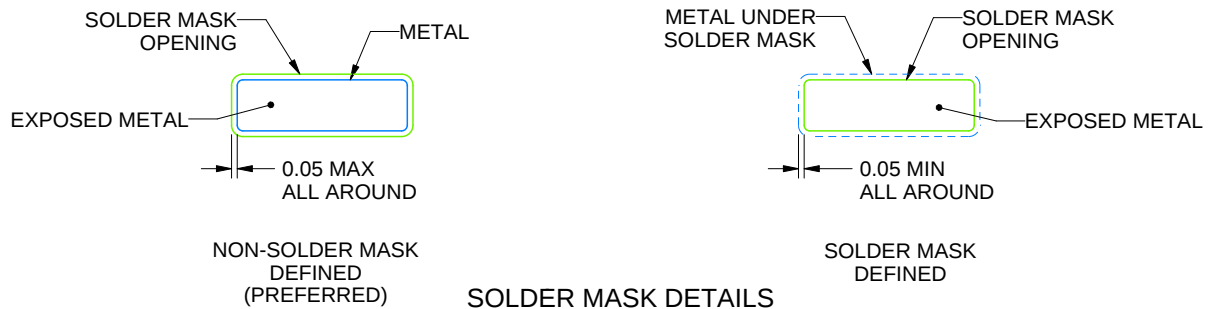
PW0016A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 10X



4220204/B 12/2023

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

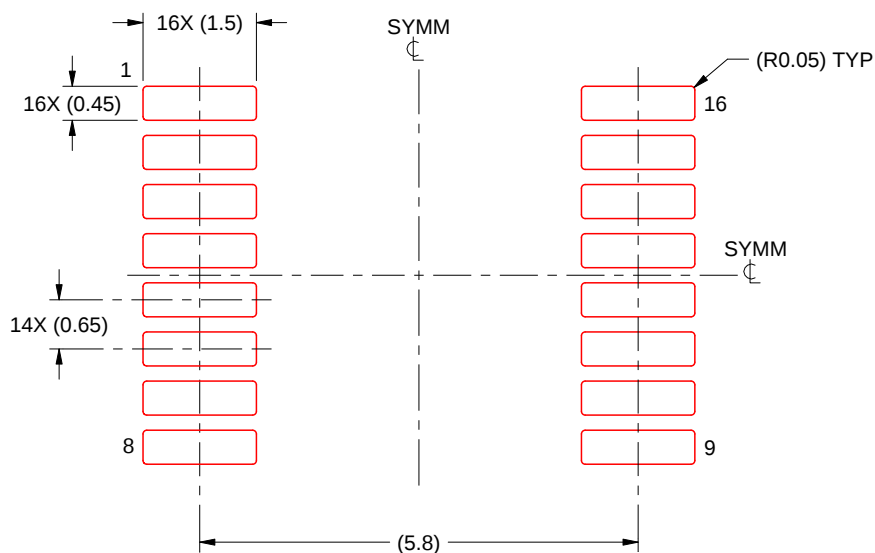
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

PW0016A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE: 10X

4220204/B 12/2023

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

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